

TL03x, TL03xA ENHANCED-JFET LOW-POWER LOW-OFFSET OPERATIONAL AMPLIFIERS

SLOS180C – FEBRUARY 1997 – REVISED DECEMBER 2001

- Direct Upgrades for the TL06x Low-Power BiFETs
- Low Power Consumption . . . 6.5 mW/Channel Typ
- On-Chip Offset-Voltage Trimming for Improved DC Performance (1.5 mV, TL031A)
- Higher Slew Rate and Bandwidth Without Increased Power Consumption
- Available in TSSOP for Small Form-Factor Designs

description

The TL03x series of JFET-input operational amplifiers offer improved dc and ac characteristics over the TL06x family of low-power BiFET operational amplifiers. On-chip zener trimming of offset voltage yields precision grades as low as 1.5 mV (TL031A) for greater accuracy in dc-coupled applications. The Texas Instruments improved BiFET process and optimized designs also yield improved bandwidths and slew rates without increased power consumption. The TL03x devices are pin-compatible with the TL06x and can be used to upgrade existing circuits or for optimal performance in new designs.

BiFET operational amplifiers offer the inherently higher input impedance of the JFET-input transistors without sacrificing the output drive associated with bipolar amplifiers. This higher input impedance makes the TL3x amplifiers better suited for interfacing with high-impedance sensors or very low-level ac signals. These devices also feature inherently better ac response than bipolar or CMOS devices having comparable power consumption.

The TL03x family has been optimized for micropower operation, while improving on the performance of the TL06x series. Designers requiring significantly faster ac response should consider the Excalibur™ TLE206x family of low-power BiFET operational amplifiers.

Because BiFET operational amplifiers are designed for use with dual power supplies, care must be taken to observe common-mode input-voltage limits and output swing when operating from a single supply. DC biasing of the input signal is required, and loads should be terminated to a virtual-ground node at midsupply. The TI TLE2426 integrated virtual-ground generator is useful when operating BiFET amplifiers from single supplies.

The TL03x devices are fully specified at ± 15 V and ± 5 V. For operation in low-voltage and/or single-supply systems, the TI LinCMOS families of operational amplifiers (TLC prefix) are recommended. When moving from BiFET to CMOS amplifiers, particular attention should be paid to slew rate, bandwidth requirements, and output loading.

The C-suffix devices are characterized for operation from 0°C to 70°C. The I-suffix devices are characterized for operation from -40°C to 85°C. The M-suffix devices are characterized for operation over the full military temperature range of -55°C to 125°C.



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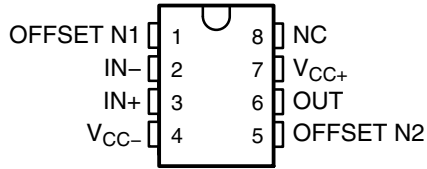
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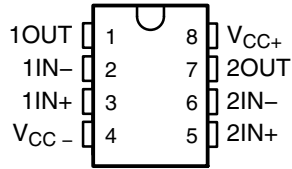
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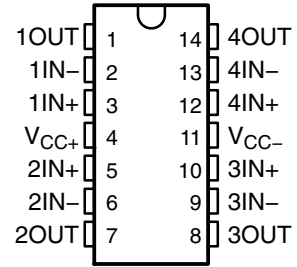
TL031x, TL031Ax
D, JG, OR P PACKAGE
(TOP VIEW)



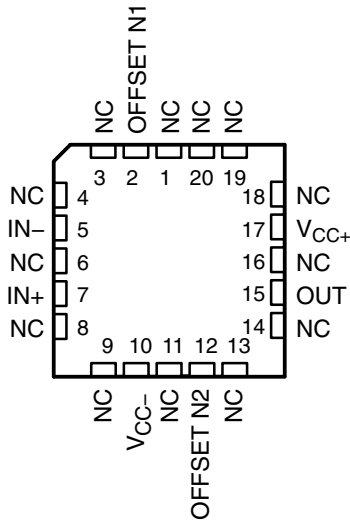
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D, JG, OR P PACKAGE
(TOP VIEW)



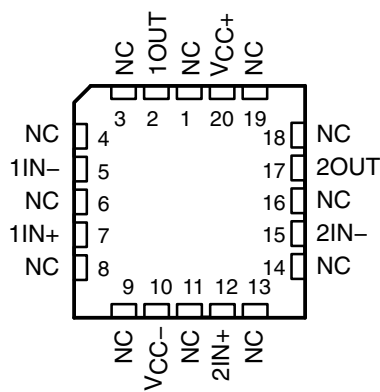
TL034x, TL034Ax
D, J, N, OR PW PACKAGE
(TOP VIEW)



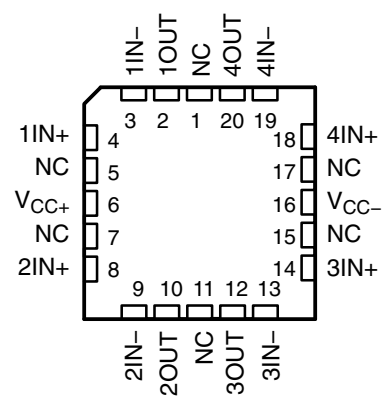
TL031M, TL031AM
FK PACKAGE
(TOP VIEW)



TL032M, TL032AM
FK PACKAGE
(TOP VIEW)



TL034M, TL034AM
FK PACKAGE
(TOP VIEW)



NC – No internal connection

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AVAILABLE OPTIONS

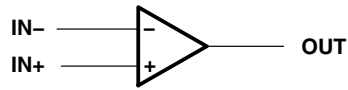
T_A	$V_{IO\text{MAX}}$ AT 25°C	PACKAGED DEVICES						
		SMALL OUTLINE (D)	CHIP CARRIER (FK)	CERAMIC DIP (J)	CERAMIC DIP (JG)	PLASTIC DIP (N)	PLASTIC DIP (P)	TSSOP (PW)
0°C to 70°C	0.8 mV	TL031ACD TL032ACD	—	—	—	—	TL031ACP TL032ACP	—
	1.5 mV	TL031CD TL032CD TL034ACD	—	—	—	TL034ACN	TL031CP TL032CP	—
	4 mV	TL034CD	—	—	—	TL034CN	—	TL034CPW
-40°C to 85°C	0.8 mV	TL031AID TL032AID	—	—	—	—	TL031AIP TL032AIP	—
	1.5 mV	TL031ID TL032ID TL034AID	—	—	—	TL034AIN	TL031IP TL032IP	—
	4 mV	TL034ID	—	—	—	TL034IN	—	—
-55°C to 125°C	0.8 mV	TL031AMD TL032AMD	TL031AMFK TL032AMFK	—	TL031AMJG TL032AMJG	—	TL031AMP TL032AMP	—
	1.5 mV	TL031MD TL032MD TL034AMD	TL031MFK TL032MFK TL034AMFK	TL034AMJ	TL031MJG TL032MJG	TL034AMN	TL031MP TL032MP	—
	4 mV	TL034MD	TL034MFK	TL034MJ	—	TL034MN	—	—

The D and PW packages are available taped and reeled and are indicated by adding an R suffix to device type (e.g., TL034CDR or TL034CPWR).

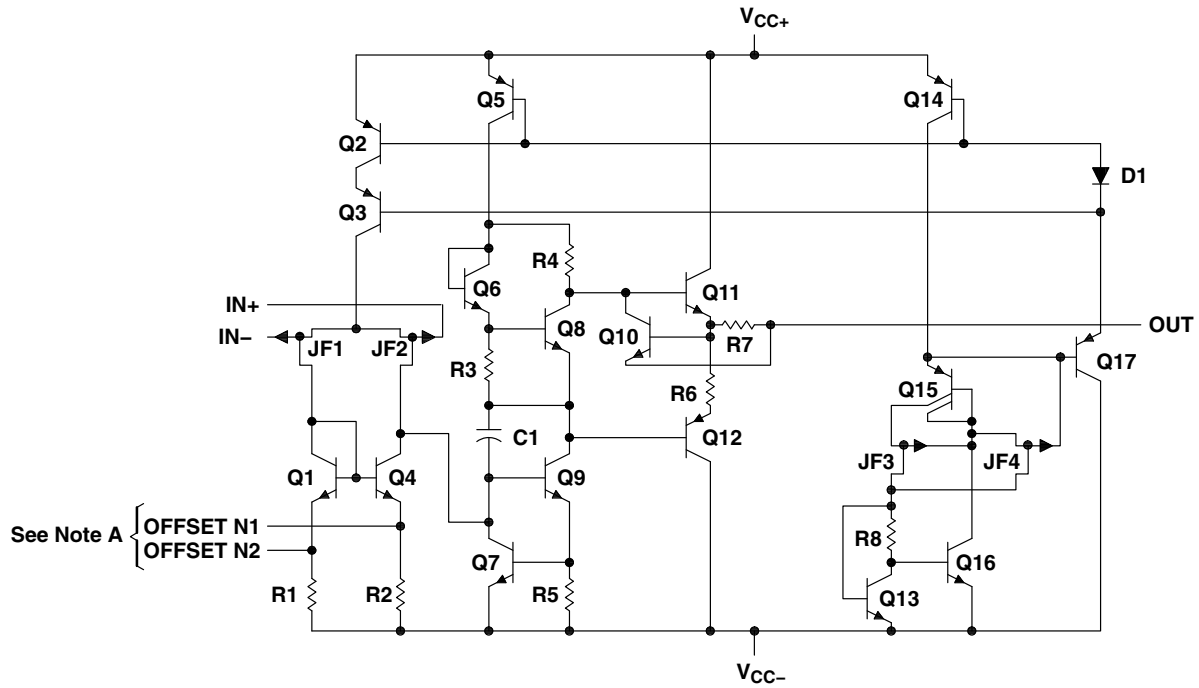
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symbol (each amplifier)



equivalent schematic (each amplifier)



NOTE A: OFFSET N1 and OFFSET N2 are available only on the TL031, TL031A.

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage (see Note 1): V_{CC+}	18 V
V_{CC-}	-18 V
Differential input voltage, V_{ID} (see Note 2)	±30 V
Input voltage, V_I (any input) (see Notes 1 and 3)	±15 V
Input current, I_I (each input)	±1 mA
Output current, I_O (each output)	±40 mA
Total current into V_{CC+}	160 mA
Total current out of V_{CC-}	160 mA
Duration of short-circuit current at (or below) 25°C (see Note 4)	Unlimited
Continuous total power dissipation	See Dissipation Rating Table
Package thermal impedance, θ_{JA} (see Note 5): D package (8 pin)	97°C/W
D package (14 pin)	86°C/W
N package	80°C/W
P package	85°C/W
PW package	113°C/W
Lead temperature 1,6 mm (1 /16 inch) from case for 10 seconds: D, N, P, or PW package	260°C
Lead temperature 1,6 mm (1 /16 inch) from case for 60 seconds: J or JG package	300°C
Case temperature for 60 seconds: FK package	260°C
Storage temperature range, T_{stg}	-65°C to 150°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES:
1. All voltage values, except differential voltages, are with respect to the midpoint between V_{CC+} and V_{CC-} .
 2. Differential voltages are at $IN+$ with respect to $IN-$.
 3. The magnitude of the input voltage must never exceed the magnitude of the supply voltage or 15 V, whichever is less.
 4. The output may be shorted to either supply. Temperature and/or supply voltages must be limited to ensure that the maximum dissipation rating is not exceeded.
 5. The package thermal impedance is calculated in accordance with JESD 51-7.

DISSIPATION RATING TABLE

PACKAGE	$T_A \leq 25^\circ\text{C}$	DERATING FACTOR ABOVE $T_A = 25^\circ\text{C}$	$T_A = 70^\circ\text{C}$	$T_A = 85^\circ\text{C}$	$T_A = 125^\circ\text{C}$
	POWER RATING		POWER RATING	POWER RATING	POWER RATING
FK	1375 mW	11.0 mW/°C	880 mW	715 mW	275 mW
J	1375 mW	11.0 mW/°C	880 mW	715 mW	275 mW
JG	1050 mW	8.4 mW/°C	672 mW	546 mW	210 mW

recommended operating conditions

		C SUFFIX		I SUFFIX		M SUFFIX		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	
$V_{CC\pm}$	Supply voltage	±5	±15	±5	±15	±5	±15	V
V_{IC}	Common-mode input voltage	$V_{CC\pm} = \pm 5\text{ V}$		-1.5	4	-1.5	4	V
		$V_{CC\pm} = \pm 15\text{ V}$		-11.5	14	-11.5	14	
T_A	Operating free-air temperature	0	70	-40	85	-55	125	°C



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TL031C and TL031AC electrical characteristics at specified free-air temperature

PARAMETER	TEST CONDITIONS		T _A	TL031C, TL031AC						UNIT
				V _{CC±} = ±5 V			V _{CC±} = ±15 V			
				MIN	TYP	MAX	MIN	TYP	MAX	
V _{IO} Input offset voltage	V _O = 0, V _{IC} = 0, R _S = 50 Ω	TL031C	25°C	0.54 3.5		0.5 1.5		mV		
			Full range†	4.5		2.5				
		TL031AC	25°C	0.41	2.8	0.34	0.8			
			Full range†	3.8		1.8				
α _{V_{IO}} Temperature coefficient of input offset voltage	V _O = 0, V _{IC} = 0, R _S = 50 Ω	TL031C	25°C to 70°C	7.1		5.9		μV/°C		
		TL031AC	25°C to 70°C	7.1		5.9 25				
Input offset voltage long-term drift‡	V _O = 0, V _{IC} = 0, R _S = 50 Ω		25°C	0.04		0.04		μV/mo		
I _{IO} Input offset current	V _O = 0, V _{IC} = 0 See Figure 5		25°C	1	100	1	100	pA		
			70°C	9	200	12	200			
I _{IB} Input bias current	V _O = 0, V _{IC} = 0 See Figure 5		25°C	2	200	2	200	pA		
			70°C	50	400	80	400			
V _{ICR} Common-mode input voltage range			25°C	-1.5 to 4	-3.4 to 5.4	-11.5 to 14	-13.4 to 15.4	V		
			Full range†	-1.5 to 4		-11.5 to 14				
V _{OM+} Maximum positive peak output voltage swing	R _L = 10 kΩ		25°C	3	4.3	13	14	V		
			0°C	3	4.2	13	14			
			70°C	3	4.3	13	14			
V _{OM-} Maximum negative peak output voltage swing	R _L = 10 kΩ		25°C	-3	-4.2	-12.5	-13.9	V		
			0°C	-3	-4.1	-12.5	-13.9			
			70°C	-3	-4.2	-12.5	-14			
A _{VD} Large-signal differential voltage amplification§	R _L = 10 kΩ		25°C	4	12	5	14.3	V/mV		
			0°C	3	11.1	4	13.5			
			70°C	4	13.3	5	15.2			
r _i Input resistance			25°C	10 ¹²		10 ¹²		Ω		
c _i Input capacitance			25°C	5		4		pF		
CMRR Common-mode rejection ratio	V _{IC} = V _{ICRmin} , V _O = 0, R _S = 50 Ω		25°C	70	87	75	94	dB		
			0°C	70	87	75	94			
			70°C	70	87	75	94			
k _{SVR} Supply-voltage rejection ratio (ΔV _{CC±} /ΔV _{IO})	V _O = 0, R _S = 50 Ω		25°C	75	96	75	96	dB		
			0°C	75	96	75	96			
			70°C	75	96	75	96			

† Full range is 0°C to 70°C.

‡ Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

§ At V_{CC±} = ±5 V, V_O = ±2.3 V; at V_{CC±} = ±15 V, V_O = ±10 V



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TL031C and TL031AC electrical characteristics at specified free-air temperature (continued)

PARAMETER	TEST CONDITIONS	T _A	TL031C, TL031AC						UNIT
			V _{CC±} = ±5 V			V _{CC±} = ±15 V			
			MIN	TYP	MAX	MIN	TYP	MAX	
P _D Total power dissipation	V _O = 0, No load	25°C		1.9	2.5		6.5	8.4	mW
		0°C		1.8	2.5		6.3	8.4	
		70°C		1.9	2.5		6.3	8.4	
I _{CC} Supply current	V _O = 0, No load	25°C		192	250		217	280	μA
		0°C		184	250		211	280	
		70°C		189	250		210	280	

TL031C and TL031AC operating characteristics at specified free-air temperature

PARAMETER	TEST CONDITIONS	T _A	TL031C, TL031AC						UNIT
			V _{CC±} = ±5 V			V _{CC±} = ±15 V			
			MIN	TYP	MAX	MIN	TYP	MAX	
SR ⁺ Positive slew rate at unity gain [†]	R _L = 10 kΩ, C _L = 100 pF See Figure 1	25°C		2		1.5	2.9	V/μs	
		0°C		1.8		1	2.6		
		70°C		2.2		1.5	3.2		
SR ⁻ Negative slew rate at unity gain [†]	R _L = 10 kΩ, C _L = 100 pF See Figure 1	25°C		3.9		1.5	5.1	V/μs	
		0°C		3.7		1.5	5		
		70°C		4		1.5	5		
t _r Rise time	V _{I(PP)} = ±10 mV, R _L = 10 kΩ, C _L = 100 pF See Figures 1 and 2	25°C		138		132		ns	
		0°C		134		127			
		70°C		150		142			
t _f Fall time	V _{I(PP)} = ±10 mV, R _L = 10 kΩ, C _L = 100 pF See Figure 1	25°C		138		132		ns	
		0°C		134		127			
		70°C		150		142			
Overshoot factor	V _{I(PP)} = ±10 mV, R _L = 10 kΩ, C _L = 100 pF See Figures 1 and 2	25°C		11%		5%			
		0°C		10%		4%			
		70°C		12%		6%			
V _n Equivalent input noise voltage	TL031C R _S = 20 Ω See Figure 3	25°C	f = 10 Hz		61		61	nV/√Hz	
			f = 1 kHz		41		41		
		25°C	f = 10 Hz		61		61		
			f = 1 kHz		41		41		60
I _n Equivalent input noise current	f = 1 kHz	25°C		0.003		0.003	pA/√Hz		
B ₁ Unity-gain bandwidth	V _I = 10 mV R _L = 10 kΩ, C _L = 25 pF See Figure 4	25°C		1		1.1	MHz		
		0°C		1		1.1			
		70°C		1		1			
φ _m Phase margin at unity gain	V _I = 10 mV R _L = 10 kΩ, C _L = 25 pF See Figure 4	25°C		61°		65°			
		0°C		61°		65°			
		70°C		60°		64°			

[†] For V_{CC±} = ±5 V, V_{I(PP)} = ±1 V; for V_{CC±} = ±15 V, V_{I(PP)} = ±5 V



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TL031I and TL031AI electrical characteristics at specified free-air temperature

PARAMETER	TEST CONDITIONS		T _A	TL031I, TL031AI						UNIT
				V _{CC±} = ±5 V			V _{CC±} = ±15 V			
				MIN	TYP	MAX	MIN	TYP	MAX	
V _{IO} Input offset voltage	V _O = 0, V _{IC} = 0, R _S = 50 Ω	TL031I	25°C	0.54	3.5		0.5	1.5	mV	
			Full range†		5.3		3.3			
		TL031AI	25°C	0.41	2.8		0.34	0.8		
			Full range†		4.6		2.6			
α _{V_{IO}} Temperature coefficient of input offset voltage	V _O = 0, V _{IC} = 0, R _S = 50 Ω	TL031I	25°C to 85°C	6.5		6.2		μV/°C		
		TL031AI	25°C to 85°C	6.5		6.2	25			
Input offset voltage long-term drift‡	V _O = 0, V _{IC} = 0, R _S = 50 Ω		25°C	0.04		0.04		μV/mo		
I _{IO} Input offset current	V _O = 0, V _{IC} = 0 See Figure 5		25°C	1	100	1	100	pA		
			85°C	0.02	0.45	0.02	0.45	nA		
I _{IB} Input bias current	V _O = 0, V _{IC} = 0 See Figure 5		25°C	2	200	2	200	pA		
			85°C	0.2	0.9	0.2	0.9	nA		
V _{ICR} Common-mode input voltage range			25°C	-1.5 to 4	-3.4 to 5.4	-11.5 to 14	-13.4 to 15.4	V		
			Full range†	-1.5 to 4		-11.5 to 14				
V _{OM+} Maximum positive peak output voltage swing	R _L = 10 kΩ		25°C	3	4.3	13	14	V		
			-40°C	3	4.1	13	14			
			85°C	3	4.4	13	14			
V _{OM-} Maximum negative peak output voltage swing	R _L = 10 kΩ		25°C	-3	-4.2	-12.5	-13.9	V		
			-40°C	-3	-4.1	-12.5	-13.8			
			85°C	-3	-4.2	-12.5	-14			
A _{VD} Large-signal differential voltage amplification§	R _L = 10 kΩ		25°C	4	12	5	14.3	V/mV		
			-40°C	3	8.4	4	11.6			
			85°C	4	13.5	5	15.3			
r _i Input resistance			25°C	10 ¹²		10 ¹²		Ω		
c _i Input capacitance			25°C	5		4		pF		
CMRR Common-mode rejection ratio	V _{IC} = V _{ICRmin} , V _O = 0, R _S = 50 Ω		25°C	70	87	75	94	dB		
			-40°C	70	87	75	94			
			85°C	70	87	75	94			
k _{SVR} Supply-voltage rejection ratio (ΔV _{CC±} /ΔV _{IO})	V _O = 0, R _S = 50 Ω		25°C	75	96	75	96	dB		
			-40°C	75	96	75	96			
			85°C	75	96	75	96			

† Full range is -40°C to 85°C.

‡ Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

§ At V_{CC±} = ±5 V, V_O = ±2.3 V; at V_{CC±} = ±15 V, V_O = ±10 V



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TL031I and TL031AI electrical characteristics at specified free-air temperature (continued)

PARAMETER	TEST CONDITIONS	T _A	TL031I, TL031AI						UNIT
			V _{CC±} = ±5 V			V _{CC±} = ±15 V			
			MIN	TYP	MAX	MIN	TYP	MAX	
P _D	Total power dissipation	V _O = 0, No load	25°C	1.9	2.5	6.5	8.4	mW	
			-40°C	1.4	2.5	5.4	8.4		
			85°C	1.9	2.5	6.2	8.4		
I _{CC}	Supply current	V _O = 0, No load	25°C	192	250	217	280	μA	
			-40°C	144	250	181	280		
			85°C	189	250	207	280		

TL031I and TL031AI operating characteristics at specified free-air temperature

PARAMETER	TEST CONDITIONS	T _A	TL031I, TL031AI						UNIT	
			V _{CC±} = ±5 V			V _{CC±} = ±15 V				
			MIN	TYP	MAX	MIN	TYP	MAX		
SR ₊	Positive slew rate at unity gain†	R _L = 10 kΩ, C _L = 100 pF See Figure 1	25°C	2			1.5 2.9		V/μs	
			-40°C	1.6			1 2.1			
			85°C	2.3			1.5 3.3			
SR ₋	Negative slew rate at unity gain†	R _L = 10 kΩ, C _L = 100 pF See Figure 1	25°C	3.9			1.5 5.1		V/μs	
			-40°C	3.3			1.5 4.8			
			85°C	4.1			1.5 4.9			
t _r	Rise time	V _{I(PP)} = ±10 mV, R _L = 10 kΩ, C _L = 100 pF See Figures 1 and 2	25°C	138			132		ns	
			-40°C	132			123			
			85°C	154			146			
t _f	Fall time	V _{I(PP)} = ±10 mV, R _L = 10 kΩ, C _L = 100 pF See Figure 1	25°C	138			132		ns	
			-40°C	132			123			
			85°C	154			146			
Overshoot factor	Overshoot factor	V _{I(PP)} = ±10 mV, R _L = 10 kΩ, C _L = 100 pF See Figures 1 and 2	25°C	11%			5%			
			-40°C	12%			5%			
			85°C	13%			7%			
V _n	Equivalent input noise voltage	TL031I	R _S = 20 Ω See Figure 3	f = 10 Hz	61			61		nV/√Hz
				f = 1 kHz	41			41		
		TL031AI	f = 10 Hz	61			61			
			f = 1 kHz	41			41 60			
I _n	Equivalent input noise current	f = 1 kHz	25°C	0.003			0.003		pA/√Hz	
B ₁	Unity-gain bandwidth	V _I = 10 mV R _L = 10 kΩ, C _L = 25 pF See Figure 4	25°C	1			1.1		MHz	
			-40°C	1			1.1			
			85°C	0.9			1			
φ _m	Phase margin at unity gain	V _I = 10 mV, R _L = 10 kΩ, C _L = 25 pF See Figure 4	25°C	61°			65°			
			-40°C	60°			65°			
			85°C	60°			64°			

† For V_{CC±} = ±5 V, V_{I(PP)} = ±1 V; for V_{CC±} = ±15 V, V_{I(PP)} = ±5 V



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TL031M and TL031AM electrical characteristics at specified free-air temperature

PARAMETER	TEST CONDITIONS		T _A	TL031M, TL031AM						UNIT
				V _{CC±} = ±5 V			V _{CC±} = ±15 V			
				MIN	TYP	MAX	MIN	TYP	MAX	
V _{IO} Input offset voltage	V _O = 0, V _{IC} = 0, R _S = 50 Ω	TL031M	25°C	0.54 3.5		0.5 1.5		mV		
			Full range†	6.5		4.5				
		TL031AM	25°C	0.41 2.8		0.34 0.8				
			Full range†	5.8		3.8				
α _{V_{IO}} Temperature coefficient of input offset voltage	V _O = 0, V _{IC} = 0, R _S = 50 Ω	TL031M	25°C to 125°C	5.1		4.3		μV/°C		
		TL031AM	25°C to 125°C	5.1		4.3				
Input offset voltage long-term drift‡	V _O = 0, V _{IC} = 0, R _S = 50 Ω		25°C	0.04		0.04		μV/mo		
I _{IO} Input offset current	V _O = 0, V _{IC} = 0 See Figure 5		25°C	1 100		1 100		pA		
			125°C	0.2 10		0.2 10		nA		
I _{IB} Input bias current	V _O = 0, V _{IC} = 0 See Figure 5		25°C	2 200		2 200		pA		
			125°C	7 20		8 20		nA		
V _{ICR} Common-mode input voltage range			25°C	-1.5 to 4	-3.4 to 5.4	-11.5 to 14	-13.4 to 15.4	V		
			Full range†	-1.5 to 4		-11.5 to 14				
V _{OM+} Maximum positive peak output voltage swing	R _L = 10 kΩ		25°C	3 4.3		13 14		V		
			-55°C	3 4.1		13 14				
			125°C	3 4.4		13 14				
V _{OM-} Maximum negative peak output voltage swing	R _L = 10 kΩ		25°C	-3 -4.2		-12.5 -13.9		V		
			-55°C	-3 -4		-12.5 -13.8				
			125°C	-3 -4.3		-12.5 -14				
A _{VD} Large-signal differential voltage amplification§	R _L = 10 kΩ		25°C	4 12		5 14.3		V/mV		
			-55°C	3 7.1		4 10.4				
			125°C	3 12.9		4 15				
r _i Input resistance			25°C	10 ¹²		10 ¹²		Ω		
c _i Input capacitance			25°C	5		4		pF		
CMRR Common-mode rejection ratio	V _{IC} = V _{ICRmin} , V _O = 0, R _S = 50 Ω		25°C	70 87		75 94		dB		
			-55°C	70 87		70 94				
			125°C	70 87		70 94				
k _{SVR} Supply-voltage rejection ratio (ΔV _{CC±} /ΔV _{IO})	V _O = 0, R _S = 50 Ω		25°C	75 96		75 96		dB		
			-55°C	75 96		75 95				
			125°C	75 96		75 96				
P _D Total power dissipation	V _O = 0, No load		25°C	1.9 2.5		6.5 8.4		mW		
			-55°C	1.1 2.5		4.7 8.4				
			125°C	1.8 2.5		5.8 8.4				

† Full range is -55°C to 125°C.

‡ Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

§ At V_{CC±} = ±5 V, V_O = ±2.3 V; at V_{CC±} = ±15 V, V_O = ±10 V



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TL031M and TL031AM electrical characteristics at specified free-air temperature (continued)

PARAMETER	TEST CONDITIONS	T _A	TL031M, TL031AM						UNIT
			V _{CC±} = ±5 V			V _{CC±} = ±15 V			
			MIN	TYP	MAX	MIN	TYP	MAX	
I _{CC}	Supply current	V _O = 0, No load	25°C	192	250	217	280	μA	
			-55°C	114	250	156	280		
			125°C	178	250	197	280		

TL031M and TL031AM operating characteristics at specified free-air temperature

PARAMETER	TEST CONDITIONS	T _A	TL031M, TL031AM						UNIT	
			V _{CC±} = ±5 V			V _{CC±} = ±15 V				
			MIN	TYP	MAX	MIN	TYP	MAX		
SR ₊	Positive slew rate at unity gain†	R _L = 10 kΩ, C _L = 100 pF See Figure 1	25°C	2			1.5 2.9			V/μs
			-55°C	1.4			1 1.9			
			125°C	2.4			1 3.5			
SR ₋	Negative slew rate at unity gain†	R _L = 10 kΩ, C _L = 100 pF See Figure 1	25°C	3.9			1.5 5.1			V/μs
			-55°C	3.2			1 4.6			
			125°C	4.1			1 4.7			
t _r	Rise time	V _{I(PP)} = ±10 mV, R _L = 10 kΩ, C _L = 100 pF See Figures 1 and 2	25°C	138			132			ns
			-55°C	142			123			
			125°C	166			158			
t _f	Fall time	V _{I(PP)} = ±10 mV, R _L = 10 kΩ, C _L = 100 pF See Figure 1	25°C	138			132			ns
			-55°C	142			123			
			125°C	166			158			
Overshoot factor		V _{I(PP)} = ±10 mV, R _L = 10 kΩ, C _L = 100 pF See Figures 1 and 2	25°C	11%			5%			
			-55°C	16%			6%			
			125°C	14%			8%			
V _n	Equivalent input noise voltage	TL031M R _S = 20 Ω See Figure 3	25°C	f = 10 Hz		61			nV/√Hz	
				f = 1 kHz		41				
			25°C	f = 10 Hz		61				
				f = 1 kHz		41				
I _n	Equivalent input noise current	f = 1 kHz	25°C	0.003			0.003		pA/√Hz	
B ₁	Unity-gain bandwidth	V _I = 10 mV, R _L = 10 kΩ, C _L = 25 pF See Figure 4	25°C	1			1.1			MHz
			-55°C	1			1.1			
			125°C	0.9			0.9			
φ _m	Phase margin at unity gain	V _I = 10 mV, R _L = 10 kΩ, C _L = 25 pF See Figure 4	25°C	61°			65°			
			-55°C	57°			64°			
			125°C	59°			62°			

† For V_{CC±} = ±5 V, V_{I(PP)} = ±1 V; for V_{CC±} = ±15 V, V_{I(PP)} = ±5 V

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TL032C and TL032AC electrical characteristics at specified free-air temperature

PARAMETER	TEST CONDITIONS		T _A	TL032C, TL032AC						UNIT
				V _{CC±} = ±5 V			V _{CC±} = ±15 V			
				MIN	TYP	MAX	MIN	TYP	MAX	
V _{IO} Input offset voltage	V _O = 0, V _{IC} = 0, R _S = 50 Ω	TL032C	25°C	0.69 3.5		0.57 1.5		mV		
			Full range†	4.5		2.5				
		TL032AC	25°C	0.53 2.8		0.39 0.8				
			Full range†	3.8		1.8				
α _{V_{IO}} Temperature coefficient of input offset voltage	V _O = 0, V _{IC} = 0, R _S = 50 Ω	TL032C	25°C to 70°C	11.5		10.8		μV/°C		
		TL032AC	25°C to 70°C	11.5		10.8 25				
Input offset voltage long-term drift‡	V _O = 0, V _{IC} = 0, R _S = 50 Ω		25°C	0.04		0.04		μV/mo		
I _{IO} Input offset current	V _O = 0, See Figure 5	V _{IC} = 0	25°C	1 100		1 100		pA		
			70°C	9 200		12 200				
I _{IB} Input bias current	V _O = 0, See Figure 5	V _{IC} = 0	25°C	2 200		2 200		pA		
			70°C	50 400		80 400				
V _{ICR} Common-mode input voltage range			25°C	-1.5 to 4	-3.4 to 5.4	-11.5 to 14	-13.4 to 15.4	V		
			Full range†	-1.5 to 4		-11.5 to 14				
V _{OM+} Maximum positive peak output voltage swing	R _L = 10 kΩ		25°C	3 4.3		13 14		V		
			0°C	3 4.2		13 14				
			70°C	3 4.3		13 14				
V _{OM-} Maximum negative peak output voltage swing	R _L = 10 kΩ		25°C	-3 -4.2		-12.5 -13.9		V		
			0°C	-3 -4.1		-12.5 -13.9				
			70°C	-3 -4.2		-12.5 -14				
A _{VD} Large-signal differential voltage amplification§	R _L = 10 kΩ		25°C	4 12		5 14.3		V/mV		
			0°C	3 11.1		4 13.5				
			70°C	4 13.3		5 15.2				
r _i Input resistance			25°C	10 ¹²		10 ¹²		Ω		
c _i Input capacitance			25°C	5		14		pF		
CMRR Common-mode rejection ratio	V _{IC} = V _{ICRmin} , V _O = 0, R _S = 50 Ω		25°C	70 87		75 94		dB		
			0°C	70 87		75 94				
			70°C	70 87		75 94				
k _{SVR} Supply-voltage rejection ratio (ΔV _{CC±} /ΔV _{IO})	V _{CC±} = ±5 V to ±15 V, V _O = 0, R _S = 50 Ω		25°C	75 96		75 96		dB		
			0°C	75 96		75 96				
			70°C	75 96		75 96				

† Full range is 0°C to 70°C.

‡ Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

§ At V_{CC±} = ±5 V, V_O = 2.3 V; at V_{CC±} = ±15 V, V_O = ±10 V



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TL032C and TL032AC electrical characteristics at specified free-air temperature (continued)

PARAMETER	TEST CONDITIONS	T _A	TL032C, TL032AC						UNIT
			V _{CC±} = ±5 V			V _{CC±} = ±15 V			
			MIN	TYP	MAX	MIN	TYP	MAX	
P _D Total power dissipation (two amplifiers)	V _O = 0, No load	25°C		3.8	5		13	17	mW
		0°C		3.7	5		12.7	17	
		70°C		3.8	5		12.6	17	
I _{CC} Supply current (two amplifiers)	V _O = 0, No load	0°C		368	500		422	560	μA
		70°C		378	500		420	560	
V _{O1} /V _{O2} Crosstalk attenuation	A _{VD} = 100 dB	25°C		120			120		dB

TL032C and TL032AC operating characteristics at specified free-air temperature

PARAMETER	TEST CONDITIONS	T _A	TL032C, TL032AC						UNIT
			V _{CC±} = ±5 V			V _{CC±} = ±15 V			
			MIN	TYP	MAX	MIN	TYP	MAX	
SR ₊ Positive slew rate at unity gain†	R _L = 10 kΩ, C _L = 100 pF See Figure 1	25°C		1.2			1.5	2.9	V/μs
		0°C		1.8			1	2.6	
		70°C		2.2			1.5	3.2	
SR ₋ Negative slew rate at unity gain†	R _L = 10 kΩ, C _L = 100 pF See Figure 1	25°C		3.9			1.5	5.1	V/μs
		0°C		3.7			1.5	5	
		70°C		4			1.5	5	
t _r Rise time	V _{I(PP)} = ±10 V, R _L = 10 kΩ, C _L = 100 pF See Figures 1 and 2	25°C		138			132		ns
		0°C		134			127		
		70°C		150			142		
t _f Fall time	V _{I(PP)} = ±10 V, R _L = 10 kΩ, C _L = 100 pF See Figures 1 and 2	25°C		138			132		ns
		0°C		134			127		
		70°C		150			142		
Overshoot factor	V _{I(PP)} = ±10 V, R _L = 10 kΩ, C _L = 100 pF See Figures 1 and 2	25°C		11%			5%		
		0°C		10%			4%		
		70°C		12%			6%		
V _n Equivalent input noise voltage	TL032C	R _S = 20 Ω See Figure 3	f = 10 Hz		49		49		nV/√Hz
			f = 1 kHz		41		41		
	TL032AC	f = 10 Hz	25°C		49		49		
		f = 1 kHz		41		41	60		
I _n Equivalent input noise current	f = 1 kHz	25°C		0.003		0.003		pA/√Hz	
B ₁ Unity-gain bandwidth	V _I = 10 mV, R _L = 10 kΩ, C _L = 25 pF See Figure 4	25°C		1			1.1		MHz
		0°C		1			1.1		
		70°C		1			1		
φ _m Phase margin at unity gain	V _I = 10 mV, R _L = 10 kΩ, C _L = 25 pF See Figure 4	25°C		61°			65°		
		0°C		61°			65°		
		70°C		60°			64°		

† For V_{CC±} = ±5 V, V_{I(PP)} = ±1 V; for V_{CC±} = ±15 V, V_{I(PP)} = ±5 V

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TL032I and TL032AI electrical characteristics at specified free-air temperature

PARAMETER	TEST CONDITIONS		T _A	TL032I, TL032AI						UNIT
				V _{CC±} = ±5 V			V _{CC±} = ±15 V			
				MIN	TYP	MAX	MIN	TYP	MAX	
V _{IO} Input offset voltage	V _O = 0, V _{IC} = 0, R _S = 50 Ω	TL032I	25°C	0.69	3.5		0.57	1.5	mV	
			Full range†			5.3		3.3		
		TL032AI	25°C		0.53	2.8		0.39		0.8
			Full range†			4.6		2.6		
α _{V_{IO}} Temperature coefficient of input offset voltage	V _O = 0, V _{IC} = 0, R _S = 50 Ω	TL032I	25°C to 85°C		11.4		10.8		μV/°C	
		TL032AI	25°C to 85°C		11.4		10.8	25		
Input offset voltage long-term drift‡	V _O = 0, V _{IC} = 0, R _S = 50 Ω		25°C		0.04		0.04		μV/mo	
I _{IO} Input offset current	V _O = 0, See Figure 5	V _{IC} = 0	25°C		1	100		1	100	pA
			85°C		0.02	0.45		0.02	0.45	nA
I _{IB} Input bias current	V _O = 0, See Figure 5	V _{IC} = 0	25°C		2	200		2	200	pA
			85°C		0.2	0.9		0.3	0.9	nA
V _{ICR} Common-mode input voltage range			25°C	-1.5 to 4	-3.4 to 5.4		-11.5 to 14	-13.4 to 15.4	V	
			Full range†	-1.5 to 4			-11.5 to 14			
V _{OM+} Maximum positive peak output voltage swing	R _L = 10 kΩ		25°C	3	4.3		13	14	V	
			-40°C	3	4.2		13	14		
			85°C	3	4.4		13	14		
V _{OM-} Maximum negative peak output voltage swing	R _L = 10 kΩ		25°C	-3	-4.2		-12.5	-13.9	V	
			-40°C	-3	-4.1		-12.5	-13.8		
			85°C	-3	-4.2		-12.5	-14		
A _{VD} Large-signal differential voltage amplification§	R _L = 10 kΩ		-40°C	3	8.4		4	11.6	V/mV	
			85°C	4	13.5		5	15.3		
r _i Input resistance			25°C		10 ¹²		10 ¹²		Ω	
c _i Input capacitance			25°C		5		4		pF	
CMRR Common-mode rejection ratio	V _{IC} = V _{ICRmin} , V _O = 0, R _S = 50 Ω		25°C	70	87		75	94	dB	
			-40°C	70	87		75	94		
			85°C	70	87		75	94		
k _{SVR} Supply-voltage rejection ratio (ΔV _{CC±} /ΔV _{IO})	V _{CC±} = ±5 V to ±15 V, V _O = 0, R _S = 50 Ω		25°C	75	96		75	96	dB	
			-40°C	75	96		75	96		
			85°C	75	96		75	96		

† Full range is -40°C to 85°C.

‡ Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

§ At V_{CC±} = ±5 V, V_O = 2.3 V; at V_{CC±} = ±15 V, V_O = ±10 V



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TL032I and TL032AI electrical characteristics at specified free-air temperature (continued)

PARAMETER	TEST CONDITIONS	T _A	TL032I, TL032AI						UNIT
			V _{CC±} = ±5 V			V _{CC±} = ±15 V			
			MIN	TYP	MAX	MIN	TYP	MAX	
P _D Total power dissipation (two amplifiers)	V _O = 0, No load	25°C		3.8	5		13	17	mW
		-40°C		2.9	5		10.9	17	
		85°C		3.7	5		12.4	17	
I _{CC} Supply current (two amplifiers)	V _O = 0, No load	25°C		384	500		434	560	μA
		-40°C		288	500		362	560	
		85°C		372	500		414	560	
V _{O1} /V _{O2} Crosstalk attenuation	A _{VD} = 100 dB	25°C		120		120		dB	

TL032I and TL032AI operating characteristics at specified free-air temperature

PARAMETER	TEST CONDITIONS	T _A	TL032I, TL032AI						UNIT
			V _{CC±} = ±5 V			V _{CC±} = ±15 V			
			MIN	TYP	MAX	MIN	TYP	MAX	
SR ₊ Positive slew rate at unity gain†	R _L = 10 kΩ, C _L = 100 pF	25°C		2		1.5	2.9	V/μs	
		-40°C		1.6		1	2.1		
		85°C		2.3		1.5	3.3		
SR ₋ Negative slew rate at unity gain†	R _L = 10 kΩ, C _L = 100 pF	25°C		3.9		1.5	5.1	V/μs	
		-40°C		3.3		1.5	4.8		
		85°C		4.1		1.5	4.9		
t _r Rise time	V _{I(PP)} = ±10 V, R _L = 10 kΩ, C _L = 100 pF See Figures 1 and 2	25°C		138		132		ns	
		-40°C		132		123			
		85°C		154		146			
t _f Fall time	V _{I(PP)} = ±10 V, R _L = 10 kΩ, C _L = 100 pF See Figure 1	25°C		138		132		ns	
		-40°C		132		123			
		85°C		154		146			
Overshoot factor	V _{I(PP)} = ±10 V, R _L = 10 kΩ, C _L = 100 pF See Figures 1 and 2	25°C		11%		5%			
		-40°C		12%		5%			
		85°C		13%		7%			
V _n Equivalent input noise voltage	TL032I R _S = 20 Ω See Figure 3	25°C	f = 10 Hz		49		49	nV/√Hz	
			f = 1 kHz		41		41		
		25°C	f = 10 Hz		49		49		
			f = 1 kHz		41		41 60		
I _n Equivalent input noise current	f = 1 kHz	25°C		0.003		0.003	pA/√Hz		
B ₁ Unity-gain bandwidth	V _I = 10 mV, R _L = 10 kΩ, C _L = 25 pF See Figure 4	25°C		1		1.1	MHz		
		-40°C		1		1.1			
		85°C		0.9		1			
φ _m Phase margin at unity gain	V _I = 10 mV, R _L = 10 kΩ, C _L = 25 pF See Figure 4	25°C		61°		65°			
		-40°C		61°		65°			
		85°C		60°		64°			

† For V_{CC±} = ±5 V, V_{I(PP)} = ±1 V; for V_{CC±} = ±15 V, V_{I(PP)} = ±5 V



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TL032M and TL032AM electrical characteristics at specified free-air temperature

PARAMETER	TEST CONDITIONS		T _A	TL032M, TL032AM						UNIT
				V _{CC±} = ±5 V			V _{CC±} = ±15 V			
				MIN	TYP	MAX	MIN	TYP	MAX	
V _{IO} Input offset voltage	V _O = 0, V _{IC} = 0, R _S = 50 Ω	TL032M	25°C	0.69	3.5		0.57	1.5	mV	
			Full range†		6.5		4.5			
		TL032AM	25°C	0.53	2.8		0.39	0.8		
			Full range†		5.8		3.8			
α _{V_{IO}} Temperature coefficient of input offset voltage	V _O = 0, V _{IC} = 0, R _S = 50 Ω	TL032M	25°C to 125°C	9.7			9.7		μV/°C	
		TL032AM	25°C to 125°C	9.7			9.7			
Input offset voltage long-term drift‡	V _O = 0, V _{IC} = 0, R _S = 50 Ω		25°C	0.04			0.04		μV/mo	
I _{IO} Input offset current	V _O = 0, V _{IC} = 0 See Figure 5		25°C	1	100		1	100	pA	
			125°C	0.2	10		0.2	10	nA	
I _{IB} Input bias current	V _O = 0, V _{IC} = 0 See Figure 5		25°C	2	200		2	200	pA	
			125°C	7	20		8	20	nA	
V _{ICR} Common-mode input voltage range			25°C	-1.5 to 4	-3.4 to 5.4		-11.5 to 14	-13.4 to 15.4	V	
		Full range†		-1.5 to 4			-11.5 to 14			
V _{OM+} Maximum positive peak output voltage swing	R _L = 10 kΩ		25°C	3	4.3		13	14	V	
			-55°C	3	4.1		13	14		
			125°C	3	4.4		13	14		
V _{OM-} Maximum negative peak output voltage swing	R _L = 10 kΩ		25°C	-3	-4.2		-12.5	-13.9	V	
			-55°C	-3	-4		-12.5	-13.8		
			125°C	-3	-4.3		-12.5	-14		
A _{VD} Large-signal differential voltage amplification§	R _L = 10 kΩ		25°C	4	12		5	14.3	V/mV	
			-55°C	3	7.1		4	10.4		
			125°C	3	12.9		4	15		
r _i Input resistance			25°C	10 ¹²			10 ¹²		Ω	
c _i Input capacitance			25°C	5			4		pF	
CMRR Common-mode rejection ratio	V _{IC} = V _{ICRmin} , V _O = 0, R _S = 50 Ω		25°C	70	87		75	94	dB	
			-55°C	70	87		70	94		
			125°C	70	87		70	94		
k _{SVR} Supply-voltage rejection ratio (ΔV _{CC±} /ΔV _{IO})	V _{CC±} = ±5 V to ±15 V, V _O = 0, R _S = 50 Ω		25°C	75	96		75	96	dB	
			-55°C	75	95		75	95		
			125°C	75	96		75	96		

† Full range is -55°C to 125°C.

‡ Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

§ At V_{CC±} = ±5 V, V_O = 2.3 V; at V_{CC±} = ±15 V, V_O = ±10 V



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TL032M and TL032AM electrical characteristics at specified free-air temperature (continued)

PARAMETER	TEST CONDITIONS	T _A	TL032M, TL032AM						UNIT
			V _{CC±} = ±5 V			V _{CC±} = ±15 V			
			MIN	TYP	MAX	MIN	TYP	MAX	
P _D Total power dissipation (two amplifiers) V _O = 0,	V _O = 0, No load	25°C	3.8 5			13 17			mW
		-55°C	2.3 5			9.4 17			
		125°C	3.6 5			11.8 17			
I _{CC} Supply current (two amplifiers)	V _O = 0, No load	25°C	384 500			434 560			μA
		-55°C	228 500			312 560			
		125°C	356 500			394 560			
V _{O1} /V _{O2} Crosstalk attenuation	A _{VD} = 100 dB	25°C	120			120			dB

TL032M and TL032AM operating characteristics at specified free-air temperature

PARAMETER	TEST CONDITIONS	T _A	TL032M, TL032AM						UNIT
			V _{CC±} = ±5 V			V _{CC±} = ±15 V			
			MIN	TYP	MAX	MIN	TYP	MAX	
SR ₊ Positive slew rate at unity gain†	R _L = 10 kΩ, C _L = 100 pF See and Figure 1	25°C	2			1.5 2.9			V/μs
		-55°C	1.4			1 1.9			
		125°C	2.4			1 3.5			
SR ₋ Negative slew rate at unity gain†	R _L = 10 kΩ, C _L = 100 pF See and Figure 1	25°C	3.9			1.5 5.1			V/μs
		-55°C	3.2			1 4.6			
		125°C	4.1			1 4.7			
t _r Rise time	V _{I(PP)} = ±10 V, R _L = 10 kΩ, C _L = 100 pF See Figures 1 and 2	25°C	138			132			ns
		-55°C	142			123			
		125°C	166			58			
t _f Fall time	V _{I(PP)} = ±10 V, R _L = 10 kΩ, C _L = 100 pF See Figure 1	25°C	138			132			ns
		-55°C	142			123			
		125°C	166			158			
Overshoot factor	V _{I(PP)} = ±10 V, R _L = 10 kΩ, C _L = 100 pF See Figures 1 and 2	25°C	11%			5%			
		-55°C	16%			6%			
		125°C	14%			8%			
V _n Equivalent input noise voltage	TL032M	25°C	R _S = 20 Ω	f = 10 Hz	49			nV/√Hz	
			f = 1 kHz	41					
	TL032AM	25°C	f = 10 Hz	49					
			f = 1 kHz	41					
I _n Equivalent input noise current	f = 1 kHz	25°C	0.003			0.003			pA/√Hz
B1 Unity-gain bandwidth	V _I = 10 mV, R _L = 10 kΩ, C _L = 25 pF See Figure 4	25°C	1			1.1			MHz
		-55°C	1			1.1			
		125°C	0.9			0.9			
φ _m Phase margin at unity gain	V _I = 10 mV, R _L = 10 kΩ, C _L = 25 pF See Figure 4	25°C	61°			65°			
		-55°C	57°			64°			
		125°C	59°			62°			

† For V_{CC±} = ±5 V, V_{I(PP)} = ±1 V; for V_{CC±} = ±15 V, V_{I(PP)} = ±5 V



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TL034C and TL034AC electrical characteristics at specified free-air temperature

PARAMETER	TEST CONDITIONS	T _A	TL034C, TL034AC						UNIT
			V _{CC±} = ±5 V			V _{CC±} = ±15 V			
			MIN	TYP	MAX	MIN	TYP	MAX	
V _{IO} Input offset voltage	V _O = 0, V _{IC} = 0, R _S = 50 Ω	TL034C	25°C	0.91	6		0.79	4	mV
			Full range†			8.2		6.2	
		TL034AC	25°C	0.7	3.5		0.58	1.5	
			Full range†			5.7		3.7	
α _{V_{IO}} Temperature coefficient of input offset voltage	V _O = 0, V _{IC} = 0, R _S = 50 Ω	TL034C	25°C to 70°C	11.6		12		μV/°C	
		TL034AC	25°C to 70°C	11.6		12	25		
Input offset voltage long-term drift‡	V _O = 0, V _{IC} = 0, R _S = 50 Ω		25°C	0.04		0.04		μV/mo	
I _{IO} Input offset current	V _O = 0, V _{IC} = 0 See Figure 5		25°C	1	100		1	100	pA
			70°C	9	200		12	200	
I _{IB} Input bias current	V _O = 0, V _{IC} = 0 See Figure 5		25°C	2	200		2	200	pA
			70°C	50	400		80	400	
V _{ICR} Common-mode input voltage range			25°C	-1.5 to 4	-3.4 to 5.4		-11.5 to 14	-13.4 to 15.4	V
			Full range†	-1.5 to 4			-11.5 to 14		
V _{OM+} Maximum positive peak output voltage swing	R _L = 10 kΩ		25°C	3	4.3		13	14	V
			0°C	3	4.2		13	14	
			70°C	3	4.3		13	14	
V _{OM-} Maximum negative peak output voltage swing	R _L = 10 kΩ		25°C	-3	-4.2		-12.5	-13.9	V
			0°C	-3	-4.1		-12.5	-13.9	
			70°C	-3	-4.2		-12.5	-14	
A _{VD} Large-signal differential voltage amplification§	R _L = 10 kΩ		25°C	4	12		5	14.3	V/mV
			0°C	3	11.1		4	13.5	
			70°C	4	13.3		5	15.2	
r _i Input resistance			25°C	10 ¹²		10 ¹²		Ω	
c _i Input capacitance			25°C	5		14		pF	
CMRR Common-mode rejection ratio	V _{IC} = V _{ICRmin} , V _O = 0, R _S = 50 Ω		25°C	70	87		75	94	dB
			0°C	70	87		75	94	
			70°C	70	87		75	94	
k _{SVR} Supply-voltage rejection ratio (ΔV _{CC±} /ΔV _{IO})	V _O = 0, R _S = 50 Ω		25°C	75	96		75	96	dB
			0°C	75	96		75	96	
			70°C	75	96		75	96	

† Full range is 0°C to 70°C.

‡ Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

§ At V_{CC±} = ±5 V, V_O = ±2.3 V; at V_{CC±} = ±15 V, V_O = ±10 V



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TL034C and TL034AC electrical characteristics at specified free-air temperature (continued)

PARAMETER	TEST CONDITIONS	T _A	TL034C, TL034AC						UNIT
			V _{CC±} = ±5 V			V _{CC±} = ±15 V			
			MIN	TYP	MAX	MIN	TYP	MAX	
P _D	Total power dissipation (two amplifiers) V _O = 0, No load	25°C	7.7	10		26	34	mW	
		0°C	7.4	10		25.3	34		
		70°C	7.6	10		25.2	34		
I _{CC}	Supply current (four amplifiers) V _O = 0, No load	25°C	0.77	1		0.87	1.12	mA	
		0°C	0.74	1		0.85	1.12		
		70°C	0.76	1		0.84	1.12		
V _{O1} /V _{O2}	Crosstalk attenuation A _{VD} = 100	25°C	120			120			dB

TL034C and TL034AC operating characteristics at specified free-air temperature

PARAMETER	TEST CONDITIONS	T _A	TL034C, TL034AC						UNIT
			V _{CC±} = ±5 V			V _{CC±} = ±15 V			
			MIN	TYP	MAX	MIN	TYP	MAX	
SR ₊	Positive slew rate at unity gain† R _L = 10 kΩ, C _L = 100 pF See Figure 1	25°C	2			1.5 2.9			V/μs
		0°C	1.8			1 2.6			
		70°C	2.2			1.5 3.2			
SR ₋	Negative slew rate at unity gain† R _L = 10 kΩ, C _L = 100 pF See Figure 1	25°C	3.9			1.5 5.1			V/μs
		0°C	3.7			1.5 5			
		70°C	4			1.5 5			
t _r	Rise time V _{I(PP)} = ±10 V, R _L = 10 kΩ, C _L = 100 pF See Figures 1 and 2	25°C	138			132			ns
		0°C	134			127			
		70°C	150			142			
t _f	Fall time V _{I(PP)} = ±10 V, R _L = 10 kΩ, C _L = 100 pF See Figure 1	25°C	138			132			ns
		0°C	134			127			
		70°C	150			142			
Overshoot factor	V _{I(PP)} = ±10 V, R _L = 10 kΩ, C _L = 100 pF See Figures 1 and 2	25°C	11%			5%			
		0°C	10%			4%			
		70°C	12%			6%			
V _n	Equivalent input noise voltage R _S = 20 Ω See Figure 3	25°C	TL034C	f = 10 Hz	83			nV/√Hz	
			TL034AC	f = 1 kHz	43				
		25°C	TL034C	f = 10 Hz	83				
			TL034AC	f = 1 kHz	43 60				
I _n	Equivalent input noise current f = 1 kHz	25°C	0.003			0.003			pA/√Hz
B ₁	Unity-gain bandwidth V _I = 10 mV R _L = 10 kΩ, C _L = 25 pF See Figure 4	25°C	1			1.1			MHz
		0°C	1			1.1			
		70°C	1			1			
φ _m	Phase margin at unity gain V _I = 10 mV, R _L = 10 kΩ, C _L = 25 pF See Figure 4	25°C	61°			65°			
		0°C	61°			65°			
		70°C	60°			64°			

† For V_{CC±} = ±5 V, V_{I(PP)} = ±1 V; for V_{CC±} = ±15 V, V_{I(PP)} = ±5 V

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TL034I and TL034AI electrical characteristics at specified free-air temperature

PARAMETER	TEST CONDITIONS		T _A	TL034I, TL034AI						UNIT
				V _{CC±} = ±5 V			V _{CC±} = ±15 V			
				MIN	TYP	MAX	MIN	TYP	MAX	
V _{IO} Input offset voltage	V _O = 0, V _{IC} = 0, R _S = 50 Ω	TL034I	25°C	0.91	3.6		0.79	4	mV	
			Full range†			9.3		7.3		
		TL034AI	25°C		0.7	3.5		0.58		1.5
			Full range†			6.8		4.8		
α _{V_{IO}} Temperature coefficient of input offset voltage	V _O = 0, V _{IC} = 0, R _S = 50 Ω	TL034I	25°C to 85°C		11.5		11.6		μV/°C	
		TL034AI	25°C to 85°C		11.5		11.6	25		
Input offset voltage long-term drift‡	V _O = 0, V _{IC} = 0, R _S = 50 Ω		25°C		0.04		0.04		μV/mo	
I _{IO} Input offset current	V _O = 0, V _{IC} = 0 See Figure 5		25°C		1	100	1	100	pA	
			85°C		0.02	0.45	0.02	0.45	nA	
I _{IB} Input bias current	V _O = 0, V _{IC} = 0 See Figure 5		25°C		2	200	2	200	pA	
			85°C		0.2	0.9	0.3	0.9	nA	
V _{ICR} Common-mode input voltage range			25°C	-1.5 to 4	-3.4 to 5.4		-11.5 to 14	-13.4 to 15.4	V	
			Full range†	-1.5 to 4			-11.5 to 14			
V _{OM+} Maximum positive peak output voltage swing	R _L = 10 kΩ		25°C	3	4.3		13	14	V	
			-40°C	3	4.1		13	14		
			85°C	3	4.4		13	14		
V _{OM-} Maximum negative peak output voltage swing	R _L = 10 kΩ		25°C	-3	-4.2		-12.5	-13.9	V	
			-40°C	-3	-4.1		-12.5	-13.8		
			85°C	-3	-4.2		-12.5	-14		
A _{VD} Large-signal differential voltage amplification§	R _L = 10 kΩ		-40°C	4	12		5	14.3	V/mV	
			85°C	3	8.4		4	11.6		
r _i Input resistance			25°C		10 ¹²		10 ¹²	Ω		
c _i Input capacitance			25°C		5		4	pF		
CMRR Common-mode rejection ratio	V _{IC} = V _{ICRmin} , V _O = 0, R _S = 50 Ω		25°C	70	87		75	94	dB	
			-40°C	70	87		75	94		
			85°C	70	87		75	94		
k _{SVR} Supply-voltage rejection ratio (ΔV _{CC±} /ΔV _{IO})	V _O = 0, R _S = 50 Ω		25°C	75	96		75	96	dB	
			-40°C	75	96		75	96		
			85°C	75	96		75	96		

† Full range is -40°C to 85°C.

‡ Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

§ At V_{CC±} = ±5 V, V_O = ±2.3 V; at V_{CC±} = ±15 V, V_O = ±10 V



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TL034I and TL034AI electrical characteristics at specified free-air temperature (continued)

PARAMETER	TEST CONDITIONS	T _A	TL034I, TL034AI						UNIT
			V _{CC±} = ±5 V			V _{CC±} = ±15 V			
			MIN	TYP	MAX	MIN	TYP	MAX	
P _D	Total power dissipation (four amplifiers)	V _O = 0, No load	25°C	7.7	10		26	34	mW
			-40°C	5.8	10		21.7	34	
			85°C	7.4	10		24.8	34	
I _{CC}	Supply current (four amplifiers)	V _O = 0, No load	25°C	0.77	1		0.87	1.12	mA
			-40°C	0.58	1		0.72	1.12	
			85°C	0.74	1		0.83	1.12	
V _{O1} /V _{O2}	Crosstalk attenuation	A _{VD} = 100	25°C	120			120	dB	

TL034I and TL034AI operating characteristics

PARAMETER	TEST CONDITIONS	T _A	TL034I, TL034AI						UNIT	
			V _{CC±} = ±5 V			V _{CC±} = ±15 V				
			MIN	TYP	MAX	MIN	TYP	MAX		
SR ₊	Positive slew rate at unity gain†	R _L = 10 kΩ, C _L = 100 pF See Figure 1	25°C	2			1.5 2.9			V/μs
			-40°C	1.6			1 2.1			
			85°C	2.3			1.5 3.3			
SR ₋	Negative slew rate at unity gain†	R _L = 10 kΩ, C _L = 100 pF See Figure 1	25°C	3.9			1.5 5.1			V/μs
			-40°C	3.3			1.5 4.8			
			85°C	4.1			1.5 4.9			
t _r	Rise time	V _{I(PP)} = ±10 V, R _L = 10 kΩ, C _L = 100 pF See Figures 1 and 2	25°C	138			132			ns
			-40°C	132			123			
			85°C	154			146			
t _f	Fall time	V _{I(PP)} = ±10 V, R _L = 10 kΩ, C _L = 100 pF See Figures 1 and 2	25°C	138			132			ns
			-40°C	132			123			
			85°C	154			146			
Overshoot factor		V _{I(PP)} = ±10 V, R _L = 10 kΩ, C _L = 100 pF See Figures 1 and 2	25°C	11%			5%			
			-40°C	12%			5%			
			85°C	13%			7%			
V _n	Equivalent input noise voltage	TL034I R _S = 20 Ω See Figure 3	25°C	f = 10 Hz			83			nV/√Hz
				f = 1 kHz			43			
			25°C	f = 10 Hz			83			
				f = 1 kHz			43 60			
I _n	Equivalent input noise current	f = 1 kHz	25°C	0.003			0.003			pA/√Hz
B ₁	Unity-gain bandwidth	V _I = 10 mV, R _L = 10 kΩ, C _L = 25 pF See Figure 4	25°C	1			1.1			MHz
			-40°C	1			1.1			
			85°C	0.9			1			
φ _m	Phase margin at unity gain	V _I = 10 mV, R _L = 10 kΩ, C _L = 25 pF See Figure 4	25°C	61°			65°			
			-40°C	61°			65°			
			85°C	60°			64°			

† For V_{CC±} = ±5 V, V_{I(PP)} = ±1 V; for V_{CC±} = ±15 V, V_{I(PP)} = ±5 V



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TL034M and TL034AM electrical characteristics at specified free-air temperature

PARAMETER	TEST CONDITIONS		T _A	TL034M, TL034AM						UNIT
				V _{CC±} = ±5 V			V _{CC±} = ±15 V			
				MIN	TYP	MAX	MIN	TYP	MAX	
V _{IO} Input offset voltage	V _O = 0, V _{IC} = 0, R _S = 50 Ω	TL034M	25°C	0.91	3.6		0.78	4	mV	
			Full range†		11		9			
		TL034AM	25°C	0.7	3.5		0.58	1.5		
			Full range†		8.5		6.5			
α _{V_{IO}} Temperature coefficient of input offset voltage	V _O = 0, V _{IC} = 0, R _S = 50 Ω	TL034M	25°C to 125°C	10.6		10.9		μV/°C		
		TL034AM	25°C to 125°C	10.6		10.9				
Input offset voltage long-term drift‡	V _O = 0, V _{IC} = 0, R _S = 50 Ω		25°C	0.04		0.04		μV/mo		
I _{IO} Input offset current	V _O = 0, V _{IC} = 0 See Figure 5		25°C	1	100		1	100	pA	
			125°C	0.2	10		0.2	10	nA	
I _{IB} Input bias current	V _O = 0, V _{IC} = 0 See Figure 5		25°C	2	200		2	200	pA	
			125°C	7	20		8	20	nA	
V _{ICR} Common-mode input voltage range			25°C	-1.5 to 4	-3.4 to 5.4		-11.5 to 14	-13.4 to 15.4	V	
			Full range†	-1.5 to 4			-11.5 to 14			
V _{OM+} Maximum positive peak output voltage swing	R _L = 10 kΩ		25°C	3	4.3		13	14	V	
			-55°C	3	4.1		13	14		
			125°C	3	4.4		13	14		
V _{OM-} Maximum negative peak output voltage swing	R _L = 10 kΩ		25°C	-3	-4.2		-12.5	-13.9	V	
			-55°C	-3	-4		-12.5	-13.8		
			125°C	-3	-4.3		-12.5	-14		
A _{VD} Large-signal differential voltage amplification§	R _L = 10 kΩ		25°C	4	12		5	14.3	V/mV	
			-55°C	3	7.1		4	10.4		
			125°C	3	12.9		4	15		
r _i Input resistance			25°C	10 ¹²		10 ¹²		Ω		
c _i Input capacitance			25°C	5		4		pF		
CMRR Common-mode rejection ratio	V _{IC} = V _{ICRmin} , V _O = 0, R _S = 50 Ω		25°C	70	87		75	94	dB	
			-55°C	70	87		70	94		
			125°C	70	87		70	94		
k _{SVR} Supply-voltage rejection ratio (ΔV _{CC±} /ΔV _{IO})	V _O = 0, R _S = 50 Ω		25°C	75	96		75	96	dB	
			-55°C	75	95		75	95		
			125°C	75	96		75	96		

† Full range is -55°C to 125°C.

‡ Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

§ At V_{CC±} = ±5 V, V_O = ±2.3 V; at V_{CC±} = ±15 V, V_O = ±10 V



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TL034M and TL034AM electrical characteristics at specified free-air temperature (continued)

PARAMETER	TEST CONDITIONS	T _A	TL034M, TL034AM						UNIT
			V _{CC±} = ±5 V			V _{CC±} = ±15 V			
			MIN	TYP	MAX	MIN	TYP	MAX	
P _D	Total power dissipation (two amplifiers)	V _O = 0, No load	25°C	7.7	10		26	34	mW
			-55°C	4.6	12		18.7	45	
			125°C	7.1	12		23.6	45	
I _{CC}	Supply current (two amplifiers)	V _O = 0, No load	25°C	0.77	1		0.87	1.12	mA
			-55°C	0.46	1.2		0.62	1.5	
			125°C	0.71	1.2		0.79	1.5	
V _{O1} /V _{O2}	Crosstalk attenuation	A _{VD} = 100	25°C	120			120		dB

TL034M and TL034AM operating characteristics at specified free-air temperature

PARAMETER	TEST CONDITIONS	T _A	TL034M, TL034AM						UNIT		
			V _{CC±} = ±5 V			V _{CC±} = ±15 V					
			MIN	TYP	MAX	MIN	TYP	MAX			
SR ₊	Positive slew rate at unity gain†	R _L = 10 kΩ, C _L = 100 pF See Figure 1	25°C	2			1.5 2.9			V/μs	
			-55°C	1.4			1 1.9				
			125°C	2.4			1 3.5				
SR ₋	Negative slew rate at unity gain†	R _L = 10 kΩ, C _L = 100 pF See Figure 1	25°C	3.9			1.5 5.1			V/μs	
			-55°C	3.2			1 4.6				
			125°C	4.1			1 4.7				
t _r	Rise time	V _{I(PP)} = ±10 V, R _L = 10 kΩ, C _L = 100 pF See Figures 1 and 2	25°C	138			132			ns	
			-55°C	142			123				
			125°C	166			58				
t _f	Fall time	V _{I(PP)} = ±10 V, R _L = 10 kΩ, C _L = 100 pF See Figure 1	25°C	138			132			ns	
			-55°C	142			123				
			125°C	166			158				
Overshoot factor		V _{I(PP)} = ±10 V, R _L = 10 kΩ, C _L = 100 pF See Figures 1 and 2	25°C	11%			5%				
			-55°C	16%			6%				
			125°C	14%			8%				
V _n	Equivalent input noise voltage	TL034M	R _S = 20 Ω See Figure 3	f = 10 Hz	25°C			83			nV/√Hz
				f = 1 kHz	25°C			43			
		TL034AM		f = 10 Hz	25°C			83			
				f = 1 kHz	25°C			43			
I _n	Equivalent input noise current	f = 1 kHz	25°C	0.003			0.003			pA/√Hz	
B1	Unity-gain bandwidth	V _I = 10 mV, R _L = 10 kΩ, C _L = 25 pF See Figure 4	25°C	1			1.1			MHz	
			-55°C	1			1.1				
			125°C	0.9			0.9				
φ _m	Phase margin at unity gain	V _I = 10 mV, R _L = 10 kΩ, C _L = 25 pF See Figure 4	25°C	61°			65°				
			-55°C	57°			64°				
			125°C	59°			62°				

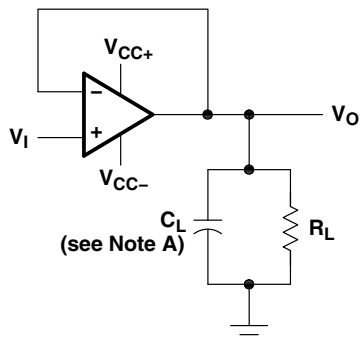
† For V_{CC±} = ±5 V, V_{I(PP)} = ±1 V; for V_{CC±} = ±15 V, V_{I(PP)} = ±5 V



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PARAMETER MEASUREMENT INFORMATION



NOTE A: C_L includes fixture capacitance.

Figure 1. Slew-Rate and Overshoot Test Circuit

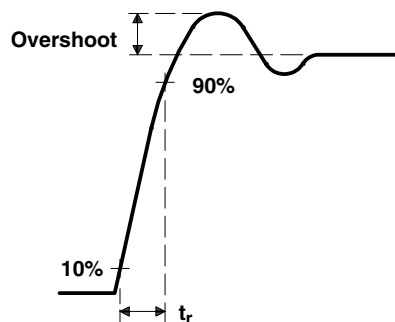


Figure 2. Rise Time and Overshoot Waveform

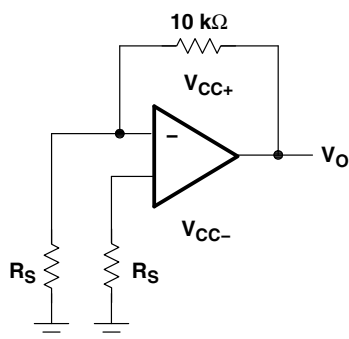
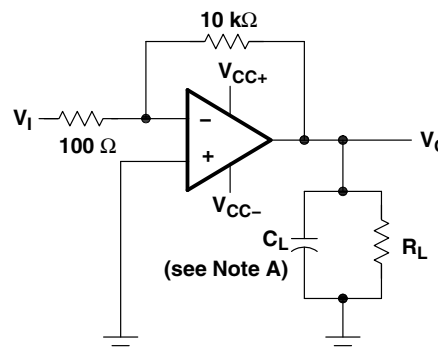


Figure 3. Noise-Voltage Test Circuit



NOTE A: C_L includes fixture capacitance.

Figure 4. Unity-Gain Bandwidth and Phase-Margin Test Circuit

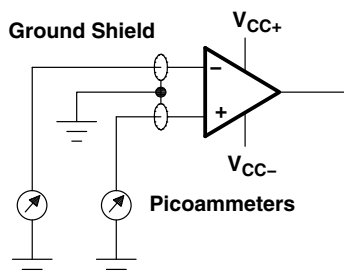


Figure 5. Input-Bias and Offset-Current Test Circuit

PARAMETER MEASUREMENT INFORMATION

typical values

Typical values presented in this data sheet represent the median (50% point) of device parametric performance.

input bias and offset current

At the picoampere bias current level typical of the TL03x and TL03xA, accurate measurement of the bias current becomes difficult. Not only does this measurement require a picoammeter, but test-socket leakages easily can exceed the actual device bias currents. To accurately measure these small currents, Texas Instruments uses a two-step process. The socket leakage is measured using picoammeters with bias voltages applied but with no device in the socket. The device is then inserted into the socket and a second test that measures both the socket leakage and the device input bias current is performed. The two measurements are then subtracted algebraically to determine the bias current of the device.

noise

With the increasing emphasis on low noise levels in many of today's applications, the input noise voltage density is performed at $f = 1$ kHz, unless otherwise noted.

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TYPICAL CHARACTERISTICS

**DISTRIBUTION OF TL031
INPUT OFFSET VOLTAGE**

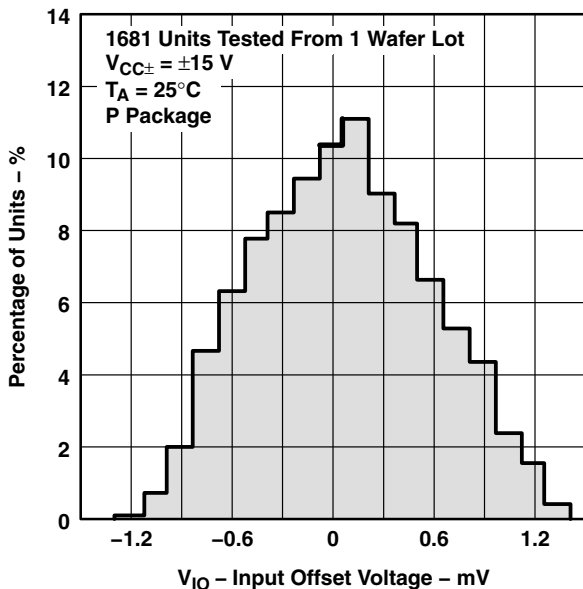


Figure 6

**DISTRIBUTION OF TL031A
INPUT OFFSET VOLTAGE**

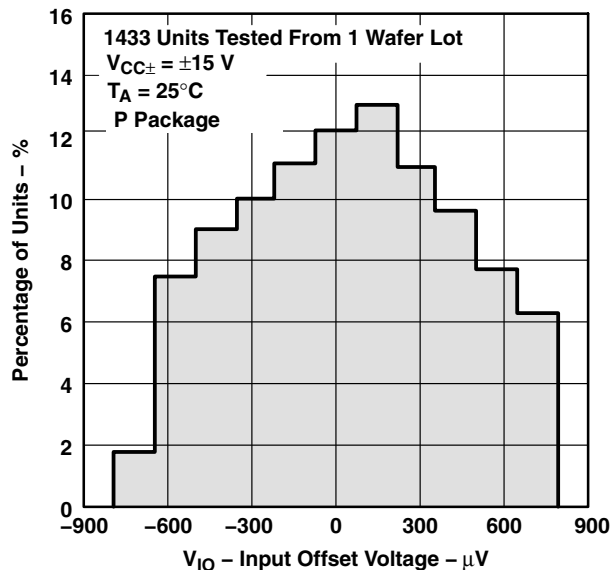


Figure 7

**DISTRIBUTION OF TL032
INPUT OFFSET VOLTAGE**

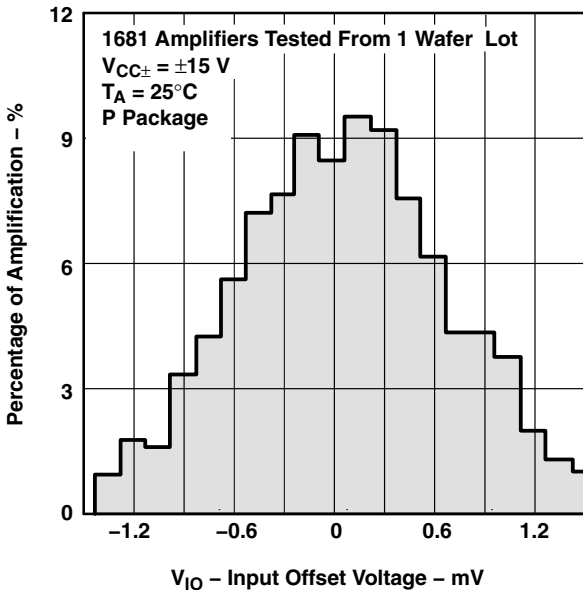


Figure 8

**DISTRIBUTION OF TL032A
INPUT OFFSET VOLTAGE**

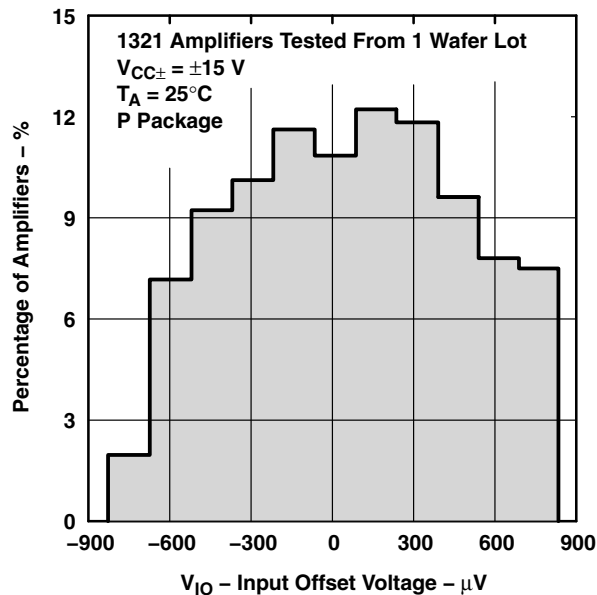


Figure 9

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TYPICAL CHARACTERISTICS

**DISTRIBUTION OF TL034
INPUT OFFSET VOLTAGE**

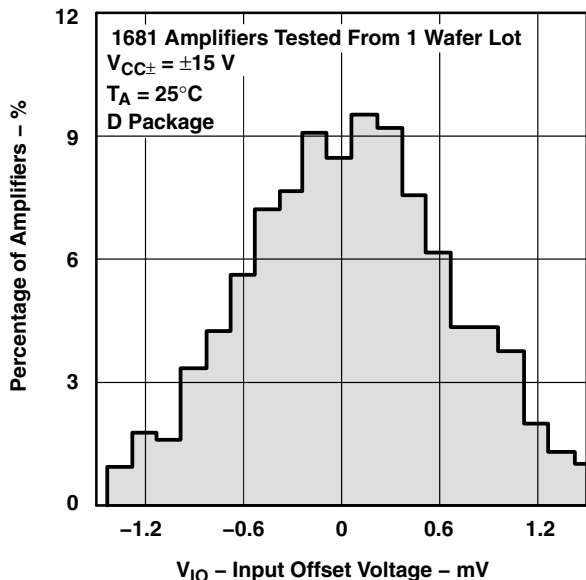


Figure 10

**DISTRIBUTION OF TL034A
INPUT OFFSET VOLTAGE**

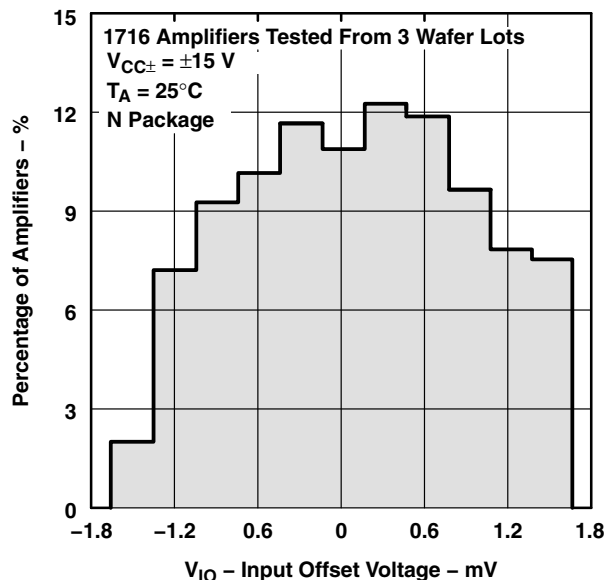


Figure 11

**DISTRIBUTION OF TL031
INPUT OFFSET-VOLTAGE
TEMPERATURE COEFFICIENT**

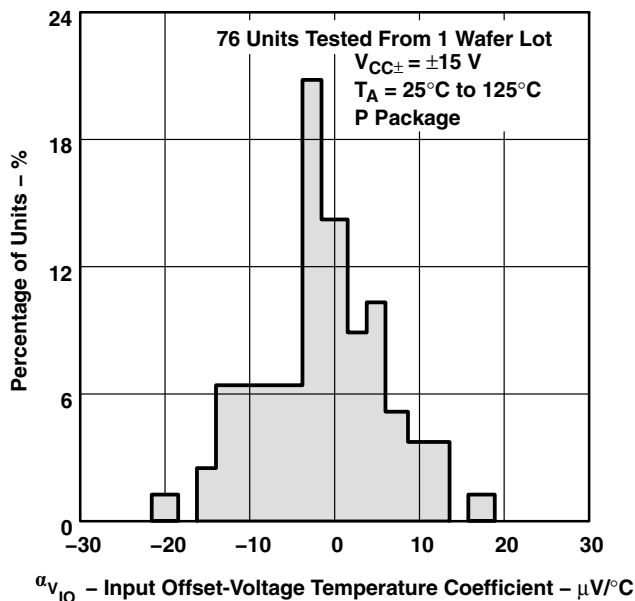


Figure 12

**DISTRIBUTION OF TL032
INPUT OFFSET-VOLTAGE
TEMPERATURE COEFFICIENT**

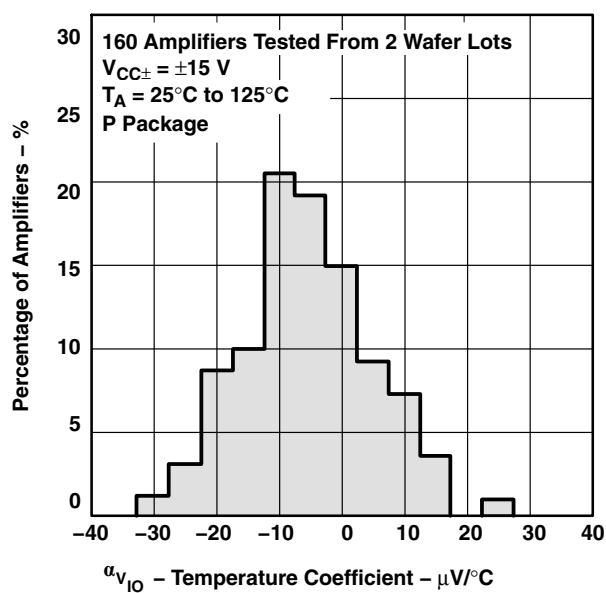


Figure 13

TYPICAL CHARACTERISTICS

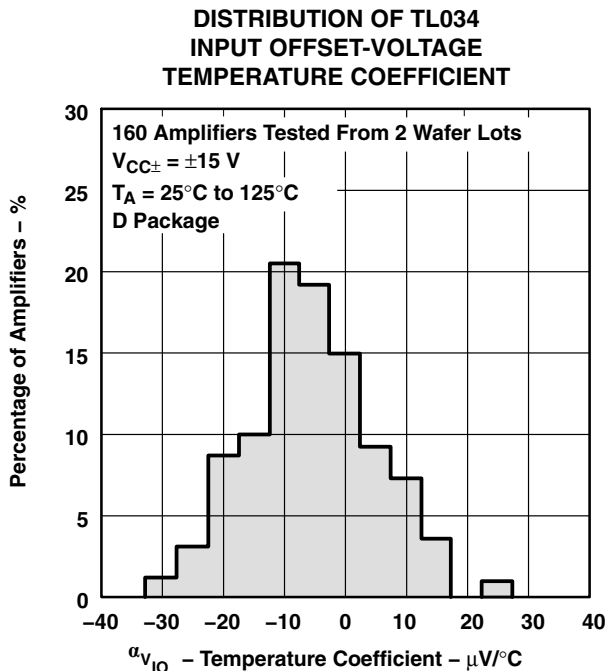


Figure 14

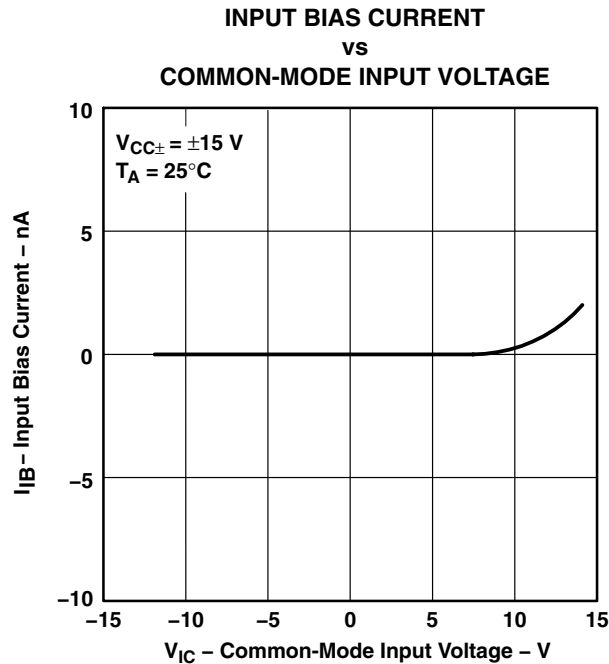


Figure 15

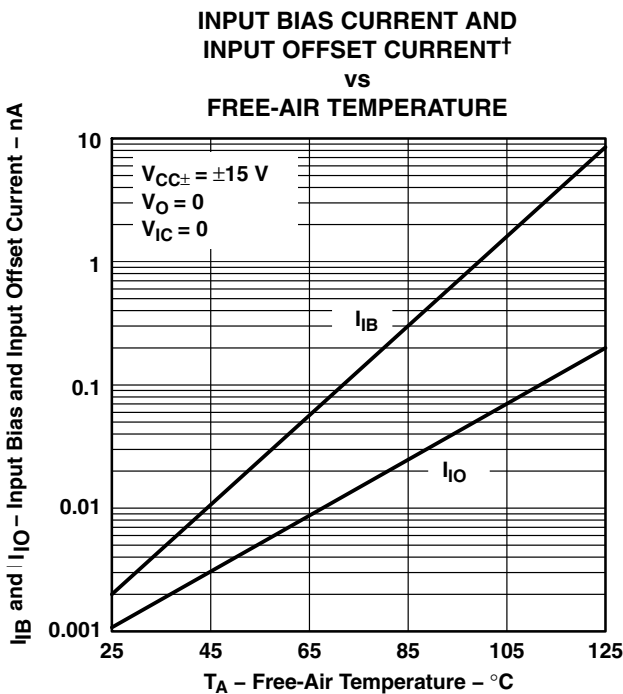


Figure 16

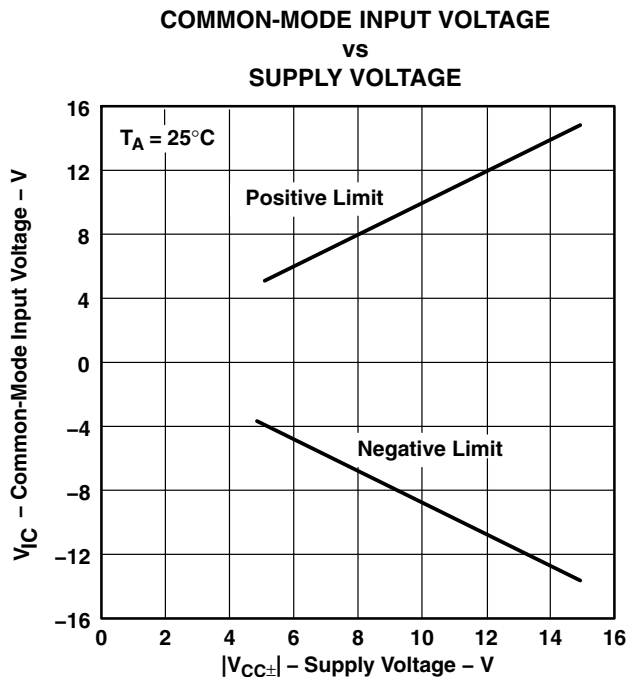


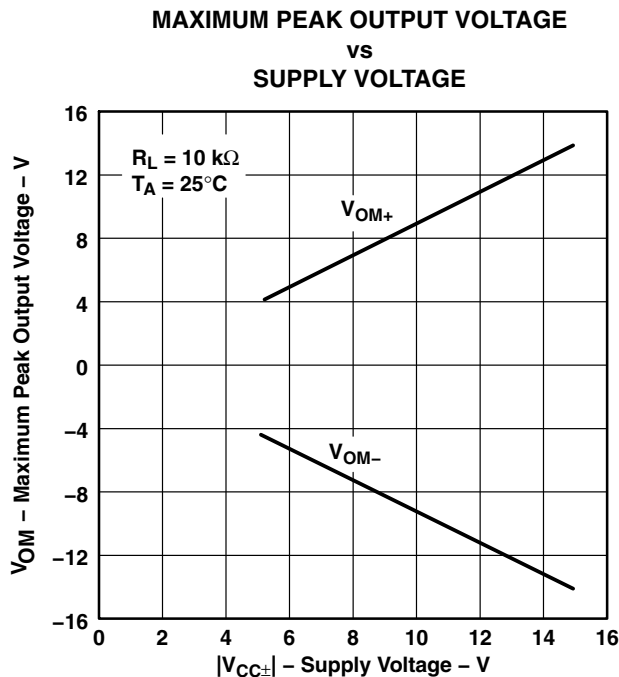
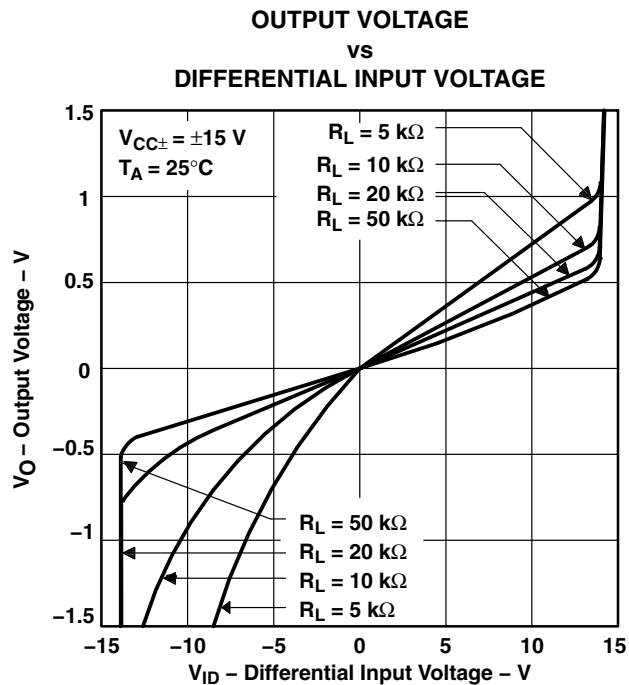
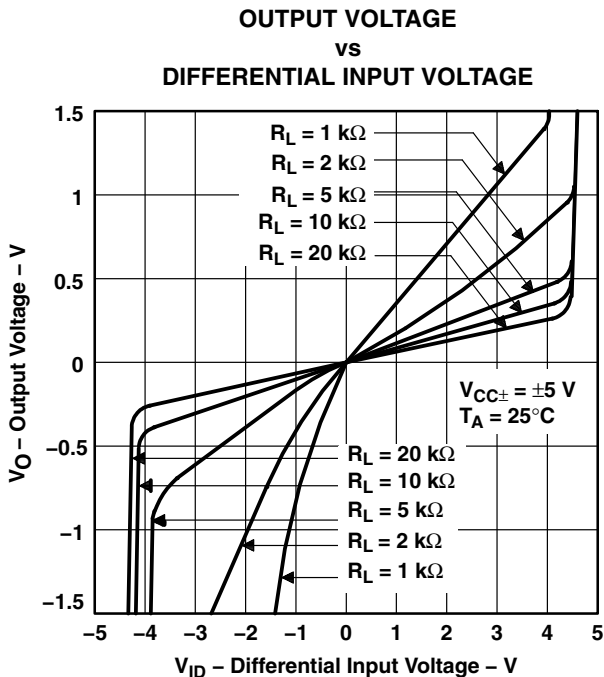
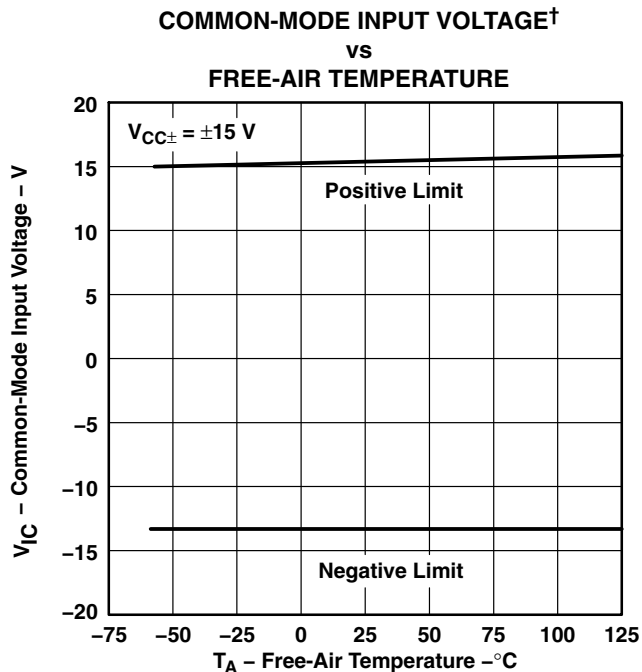
Figure 17

† Data at high and low temperatures are applicable only within the recommended operating free-air temperature ranges of the various devices.

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† Data at high and low temperatures are applicable only within the recommended operating free-air temperature ranges of the various devices.



TYPICAL CHARACTERISTICS

**MAXIMUM PEAK-TO-PEAK OUTPUT VOLTAGE†
vs
FREQUENCY**

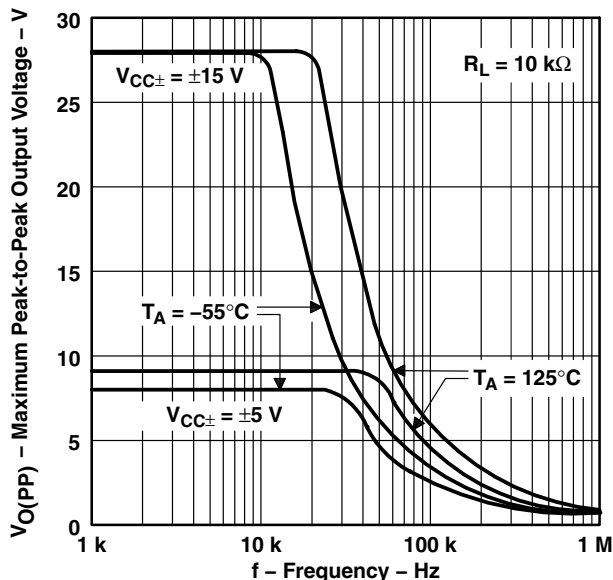


Figure 22

**MAXIMUM PEAK OUTPUT VOLTAGE
vs
OUTPUT CURRENT**

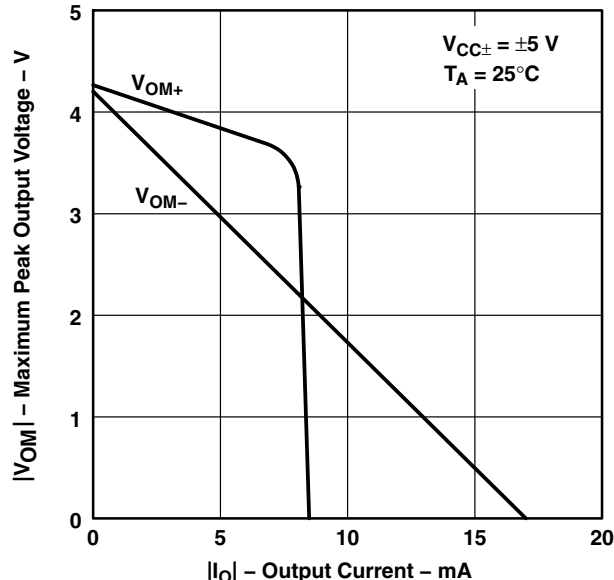


Figure 23

**MAXIMUM PEAK OUTPUT VOLTAGE
vs
OUTPUT CURRENT**

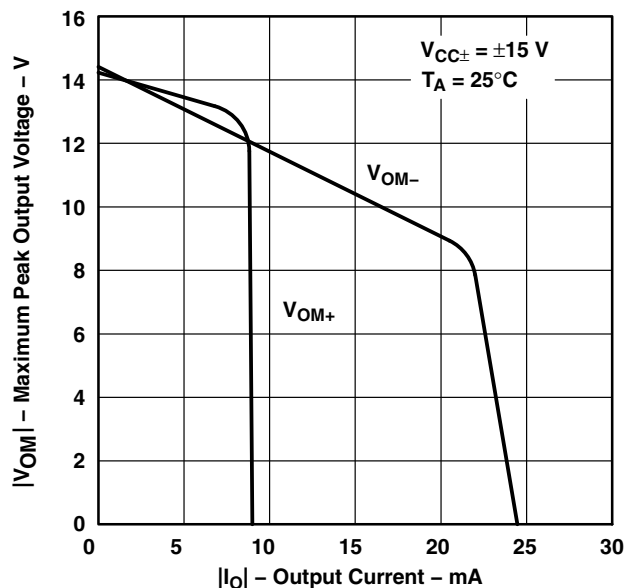


Figure 24

**MAXIMUM PEAK OUTPUT VOLTAGE†
vs
FREE-AIR TEMPERATURE**

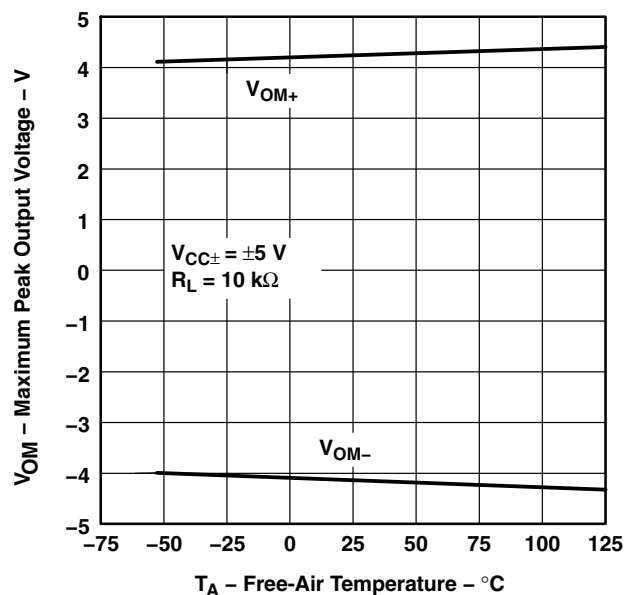


Figure 25

† Data at high and low temperatures are applicable only within the recommended operating free-air temperature ranges of the various devices.

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TYPICAL CHARACTERISTICS

MAXIMUM PEAK OUTPUT VOLTAGE†
vs
FREE-AIR TEMPERATURE

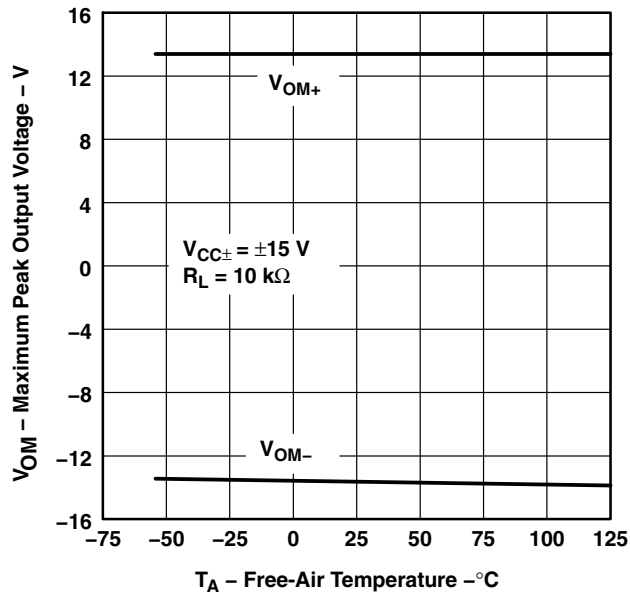


Figure 26

LARGE-SIGNAL DIFFERENTIAL
VOLTAGE AMPLIFICATION
vs
LOAD RESISTANCE

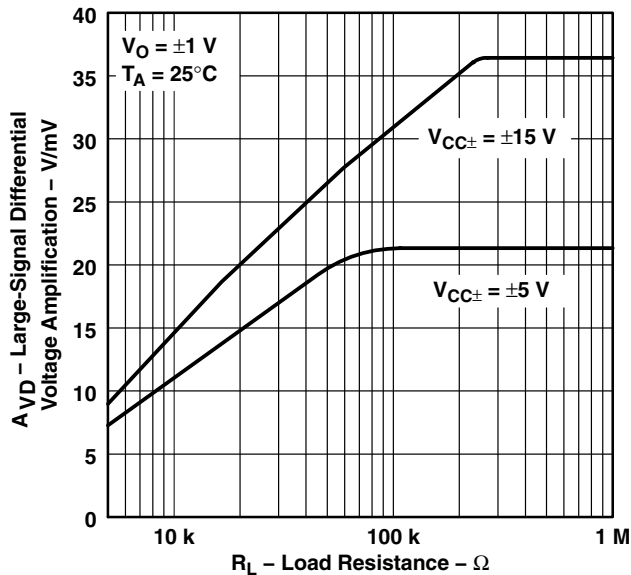


Figure 27

LARGE-SIGNAL DIFFERENTIAL VOLTAGE
AMPLIFICATION AND PHASE SHIFT
vs
FREQUENCY

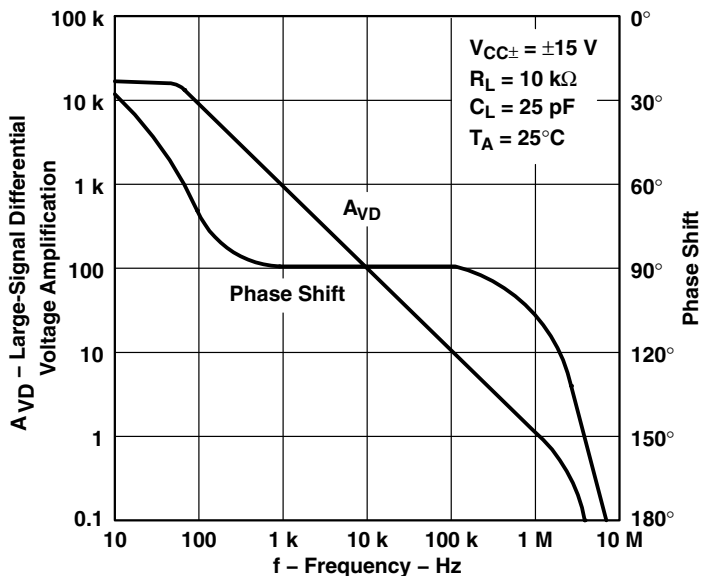


Figure 28

† Data at high and low temperatures are applicable only within the recommended operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS

**LARGE-SIGNAL DIFFERENTIAL
 VOLTAGE AMPLIFICATION†
 vs
 FREE-AIR TEMPERATURE**

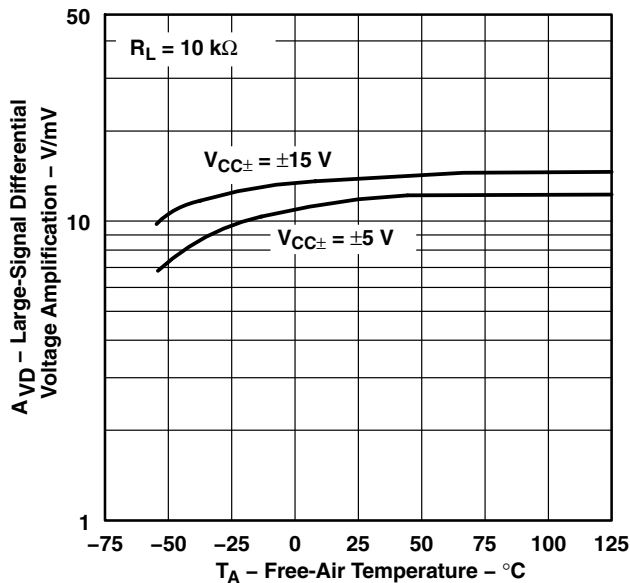


Figure 29

**OUTPUT IMPEDANCE
 vs
 FREQUENCY**

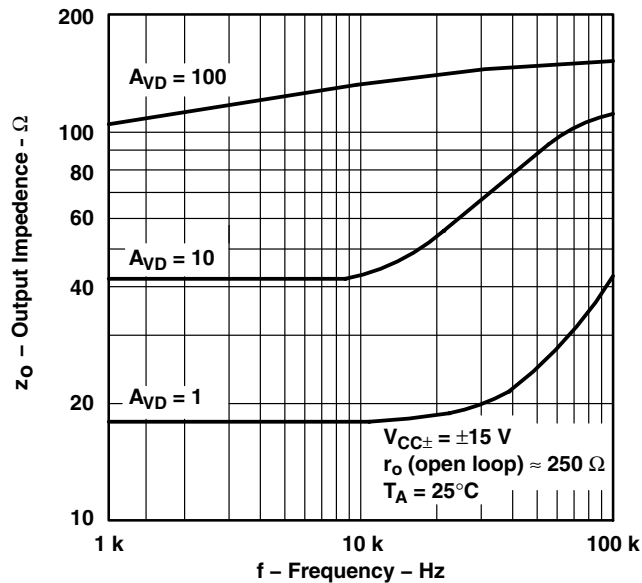


Figure 30

**COMMON-MODE REJECTION RATIO
 vs
 FREQUENCY**

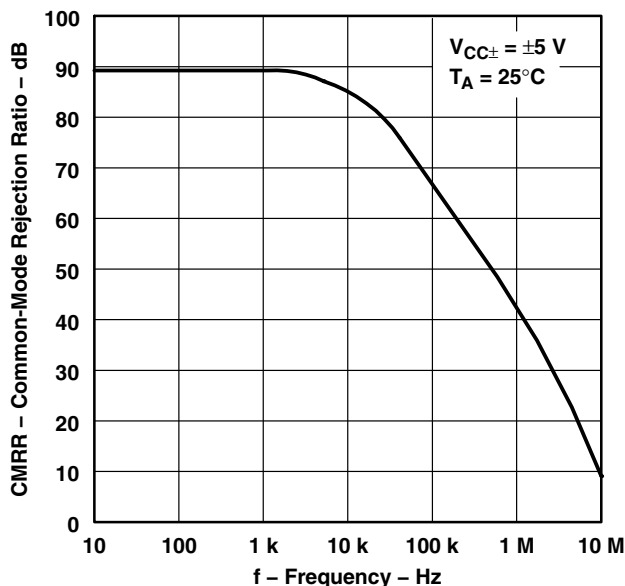


Figure 31

**COMMON-MODE REJECTION RATIO
 vs
 FREQUENCY**

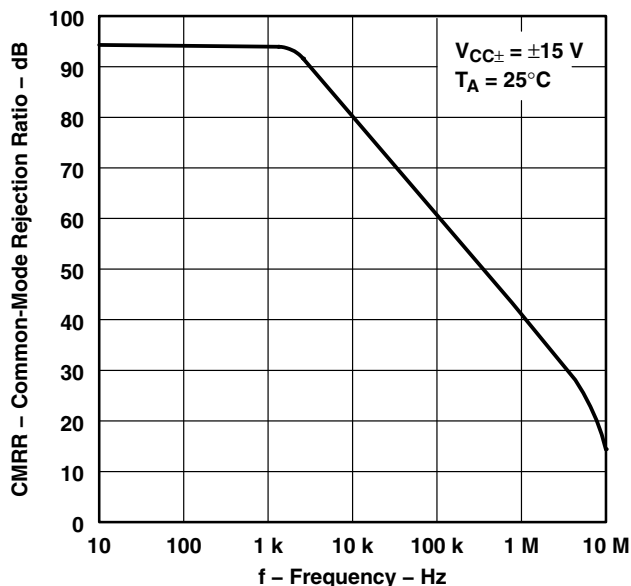


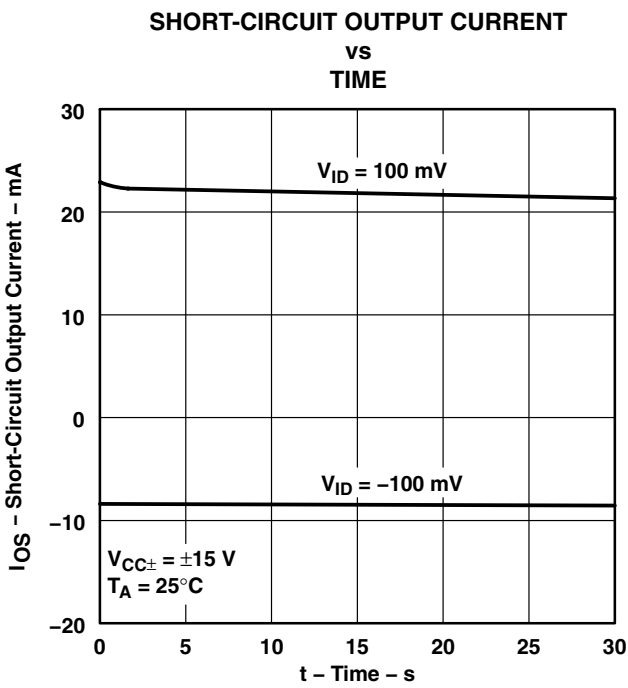
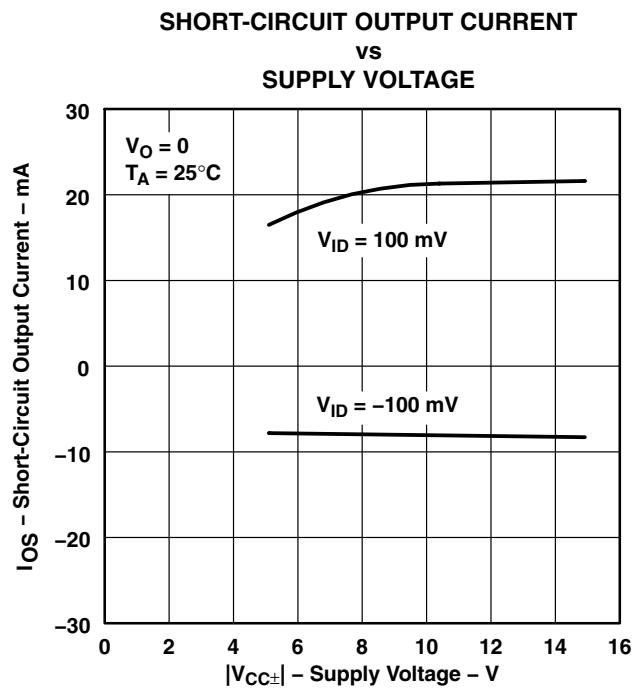
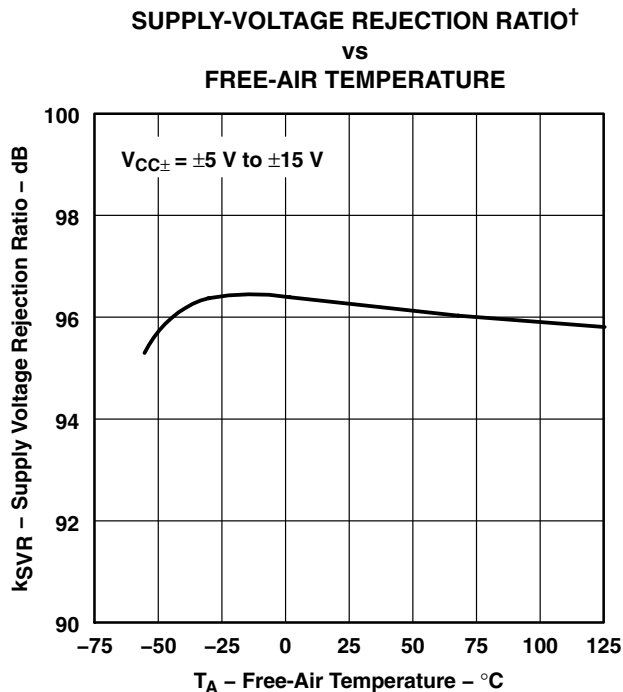
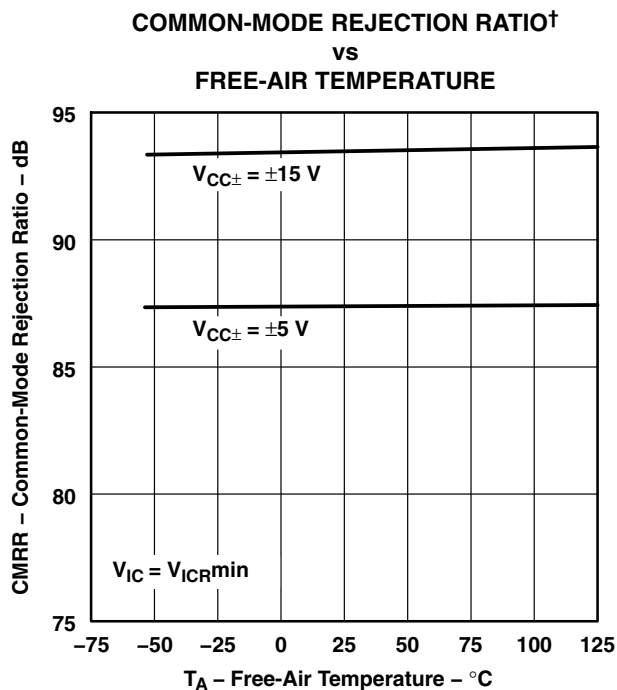
Figure 32

† Data at high and low temperatures are applicable only within the recommended operating free-air temperature ranges of the various devices.

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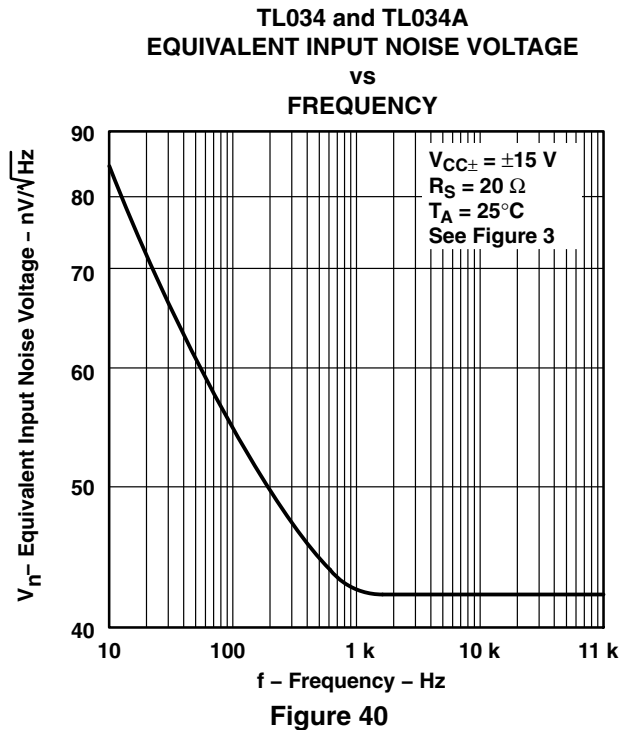
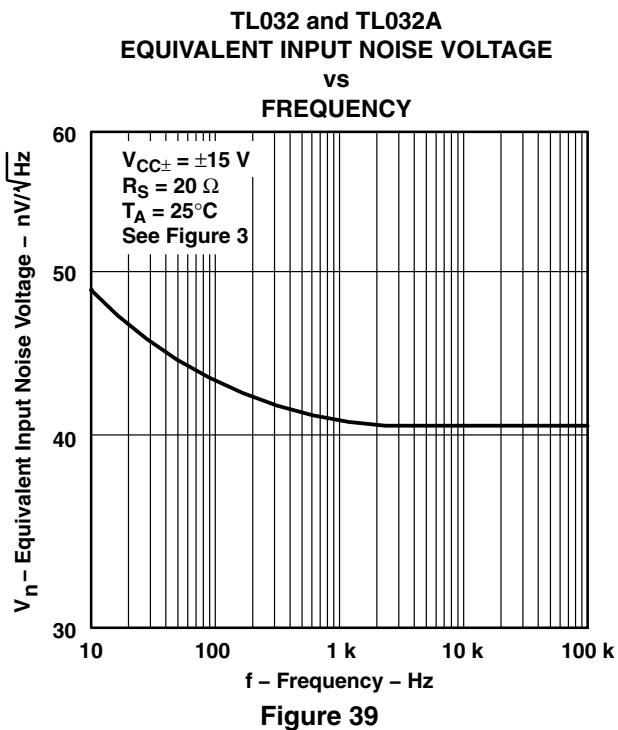
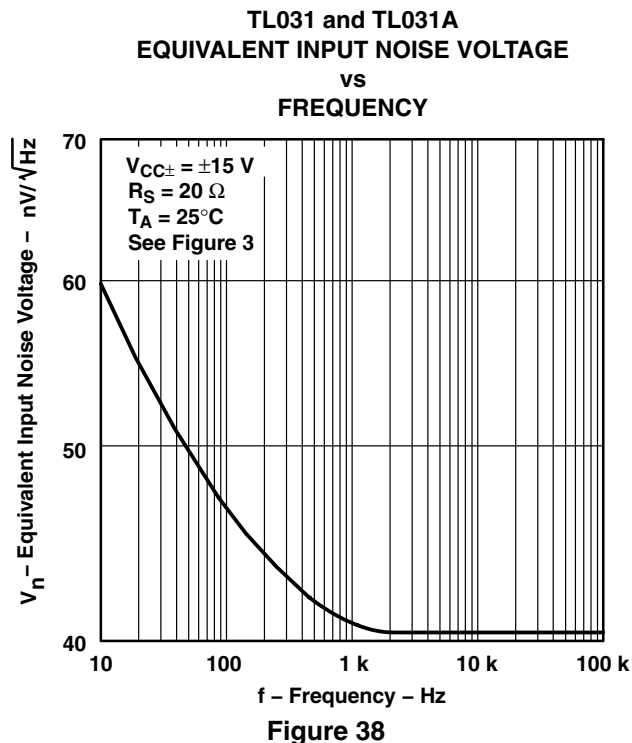
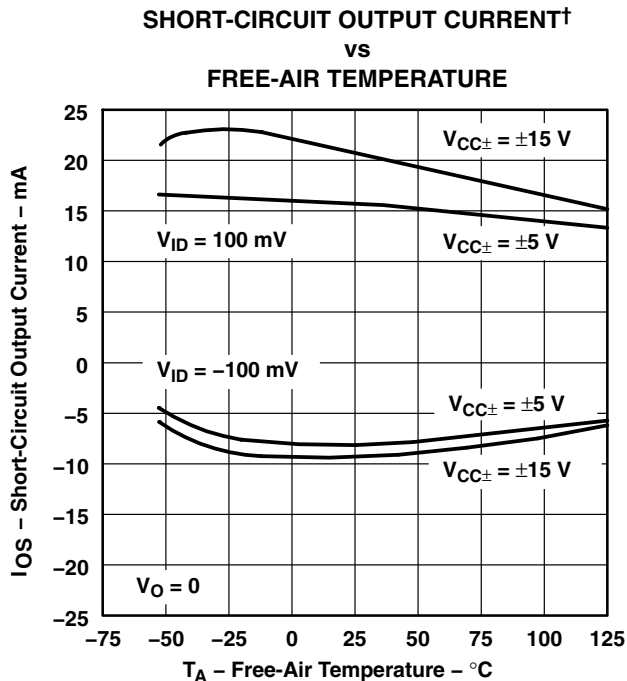
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† Data at high and low temperatures are applicable only within the recommended operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS



† Data at high and low temperatures are applicable only within the recommended operating free-air temperature ranges of the various devices.

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TYPICAL CHARACTERISTICS

TL031 and TL031A
SUPPLY CURRENT†
vs
SUPPLY VOLTAGE

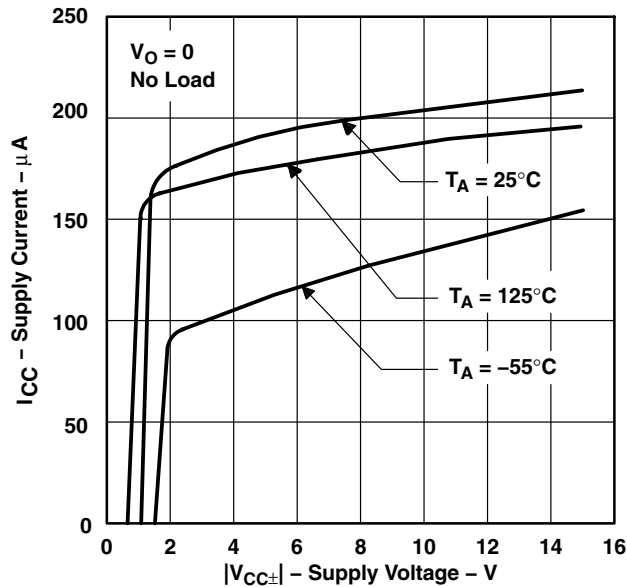


Figure 41

TL032 and TL032A
SUPPLY CURRENT†
vs
SUPPLY VOLTAGE

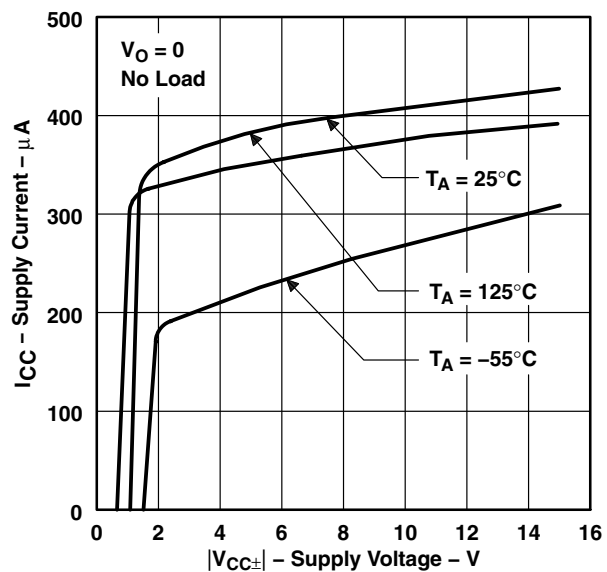


Figure 42

TL034 and TL034A
SUPPLY CURRENT†
vs
SUPPLY VOLTAGE

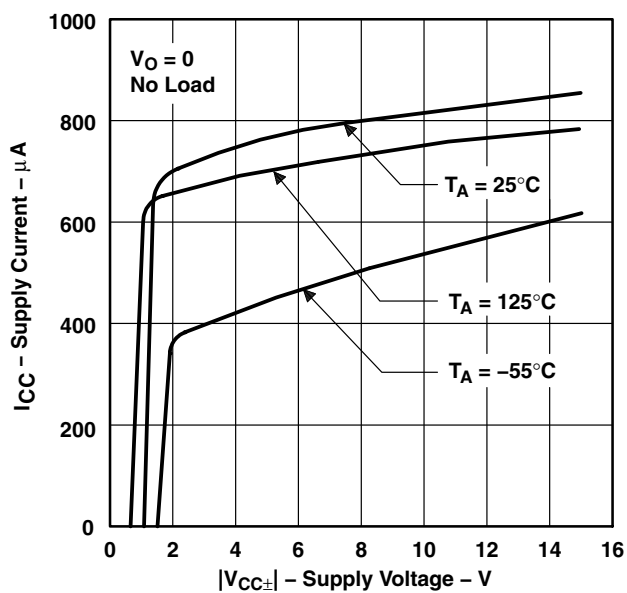


Figure 43

TL031 and TL031A
SUPPLY CURRENT†
vs
FREE-AIR TEMPERATURE

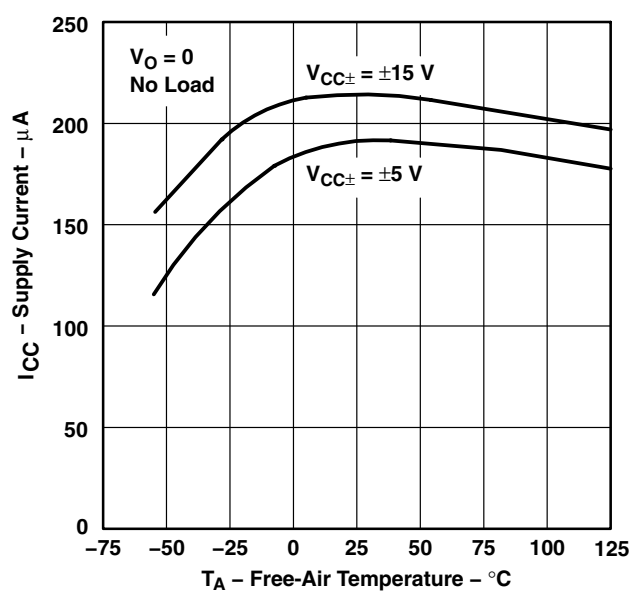
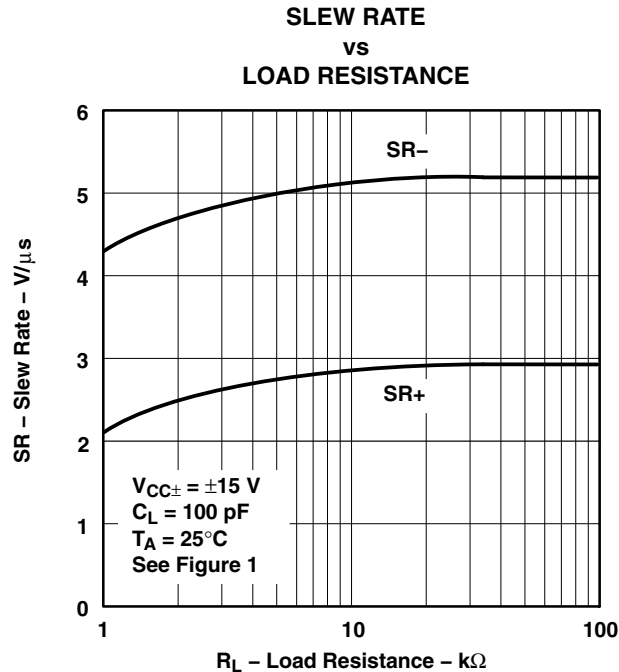
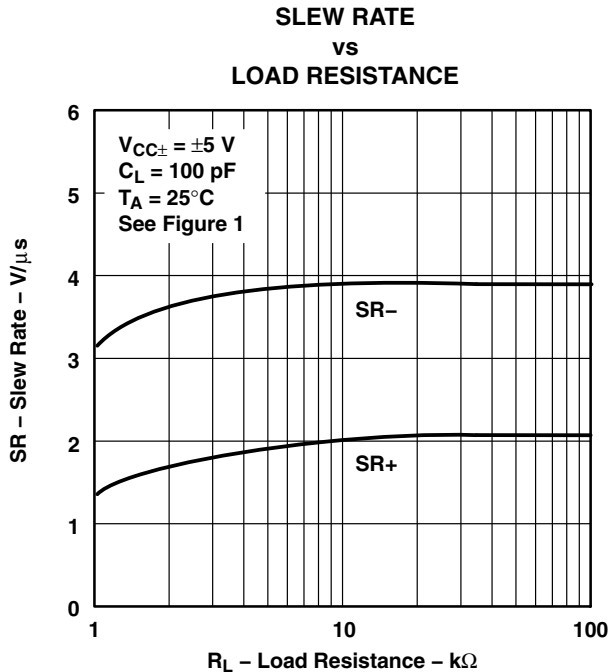
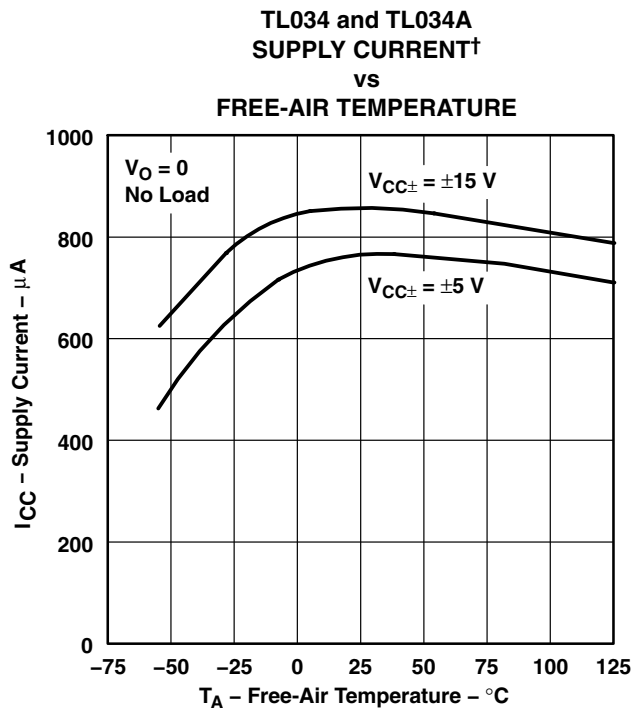
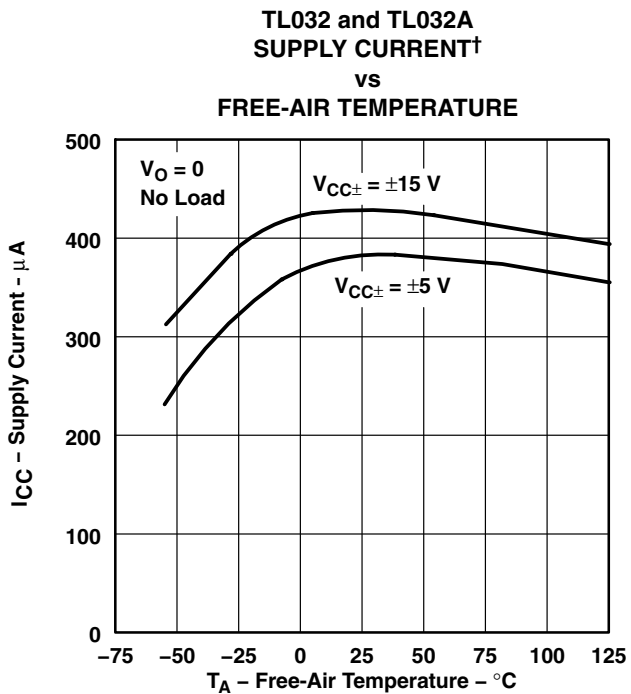


Figure 44

† Data at high and low temperatures are applicable only within the recommended operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS



† Data at high and low temperatures are applicable only within the recommended operating free-air temperature ranges of the various devices.

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TYPICAL CHARACTERISTICS

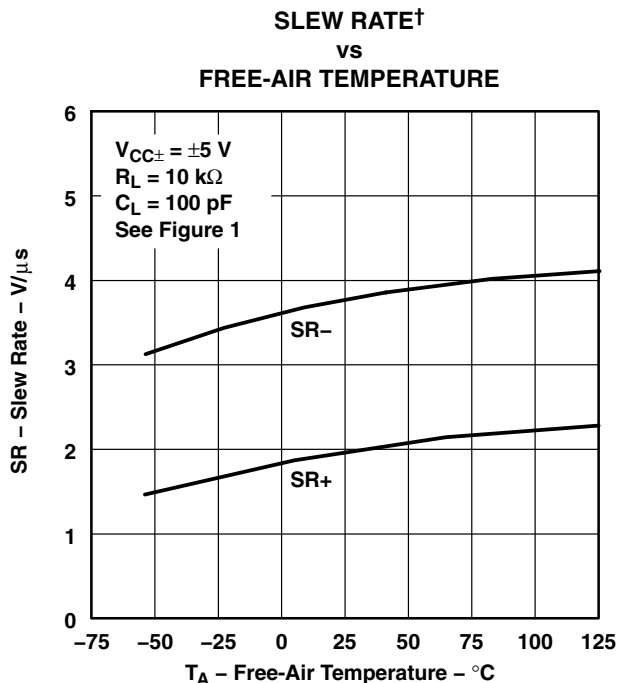


Figure 49

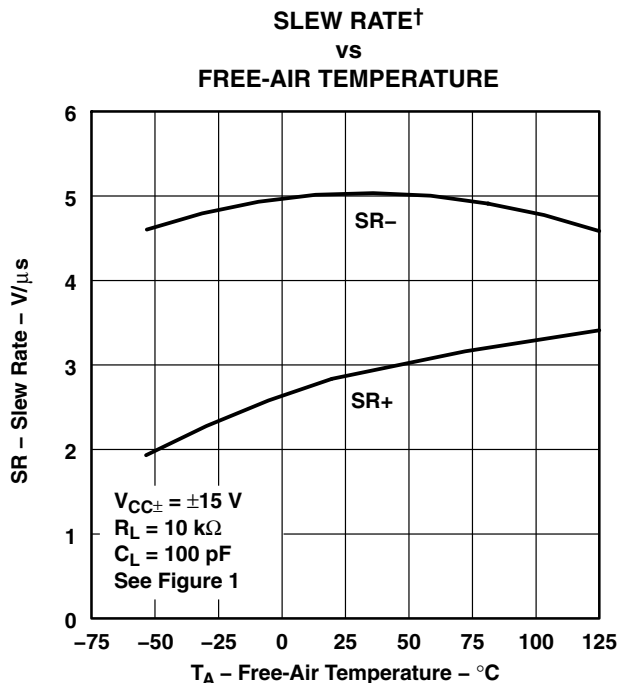


Figure 50

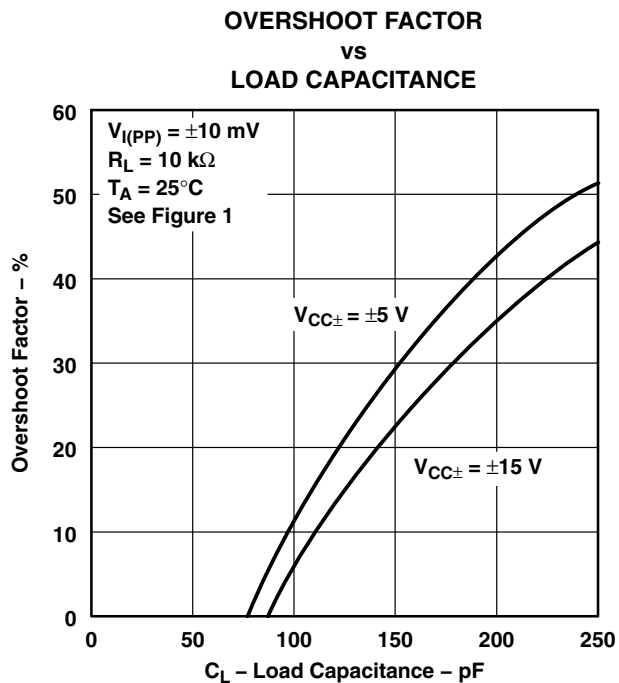


Figure 51

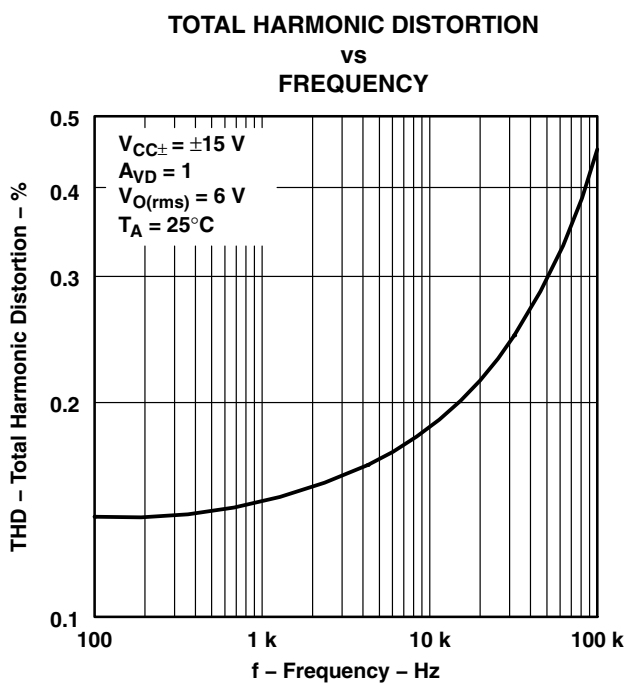


Figure 52

† Data at high and low temperatures are applicable only within the recommended operating free-air temperature ranges of the various devices.



TYPICAL CHARACTERISTICS

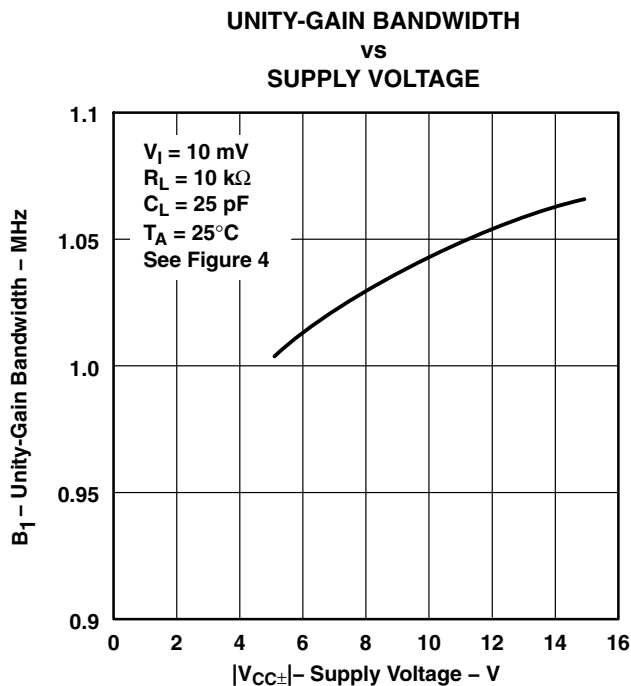


Figure 53

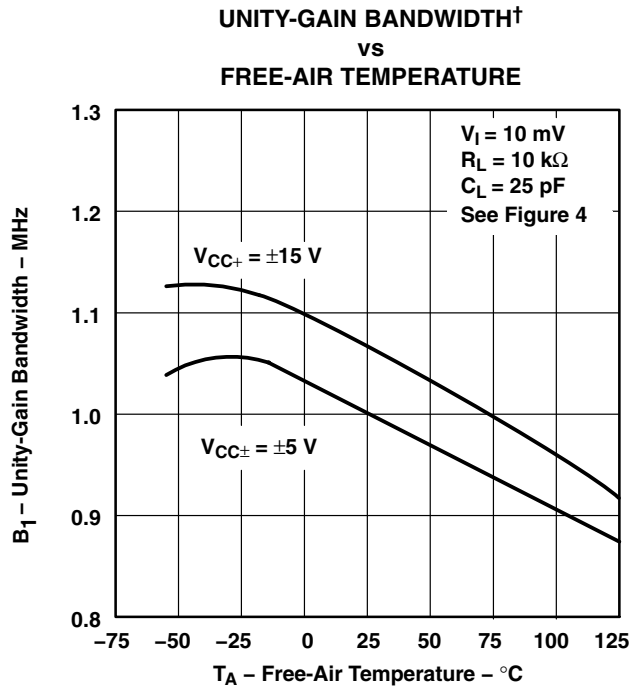


Figure 54

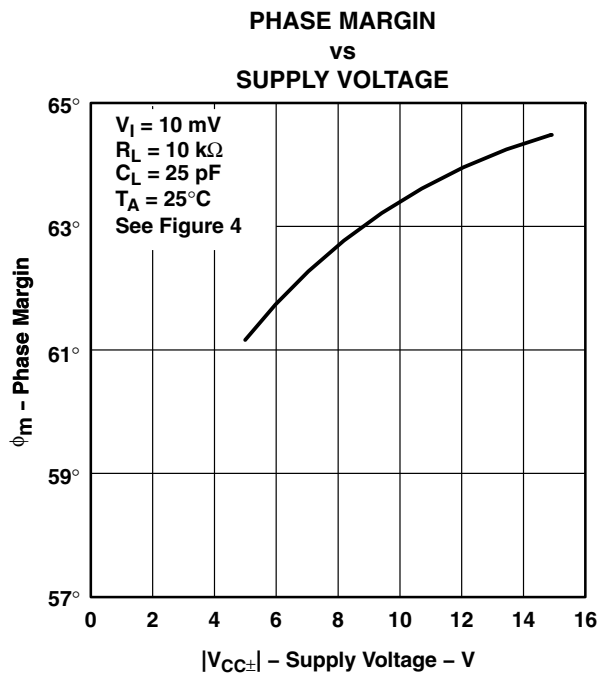
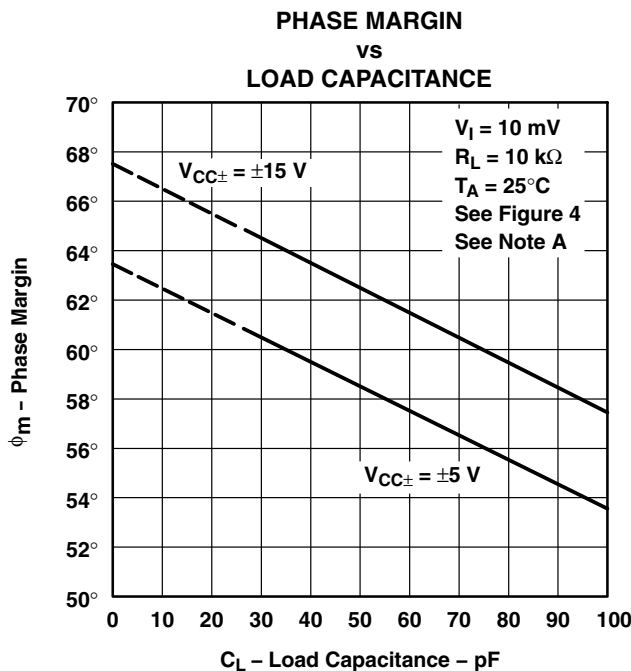


Figure 55



NOTE A: Values of phase margin below a load capacitance of 25 pF were estimated.

Figure 56

† Data at high and low temperatures are applicable only within the recommended operating free-air temperature ranges of the various devices.

TL03x, TL03xA ENHANCED-JFET LOW-POWER LOW-OFFSET OPERATIONAL AMPLIFIERS

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TYPICAL CHARACTERISTICS

**PHASE MARGIN†
vs
FREE-AIR TEMPERATURE**

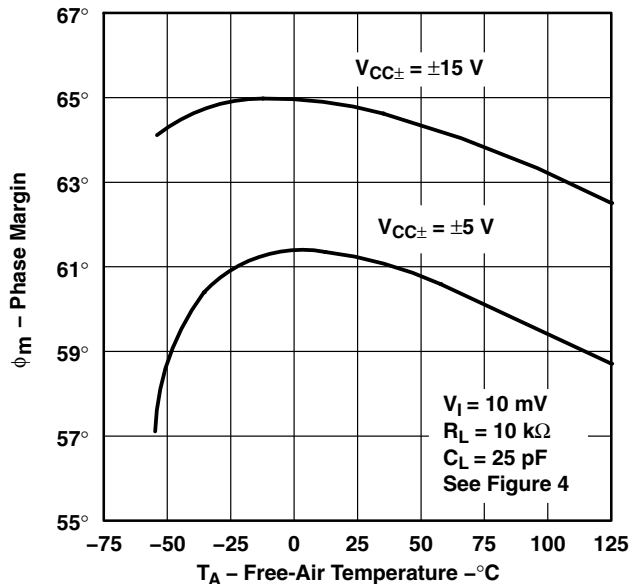


Figure 57

**VOLTAGE-FOLLOWER
SMALL-SIGNAL
PULSE RESPONSE**

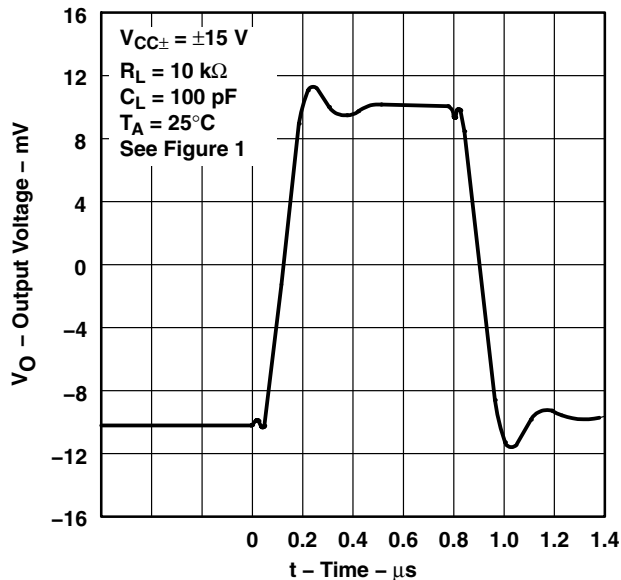


Figure 58

**VOLTAGE-FOLLOWER
LARGE-SIGNAL
PULSE RESPONSE**

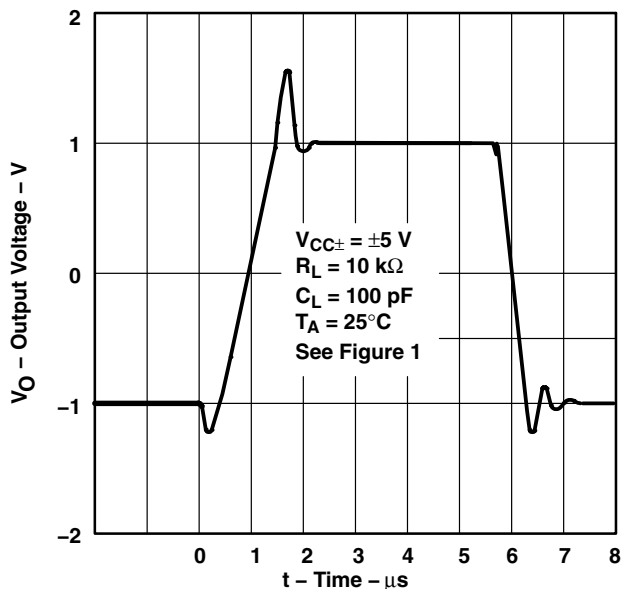


Figure 59

**VOLTAGE-FOLLOWER
LARGE-SIGNAL
PULSE RESPONSE**

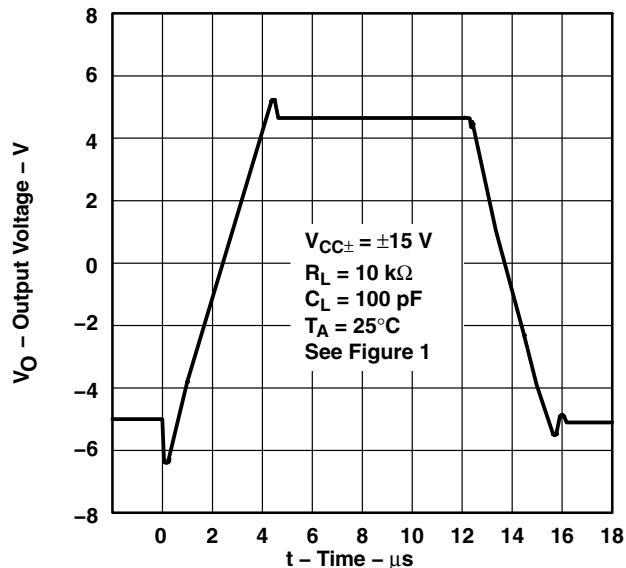


Figure 60

† Data at high and low temperatures are applicable only within the recommended operating free-air temperature ranges of the various devices.

APPLICATION INFORMATION

input characteristics

The TL03x and TL03xA are specified with a minimum and a maximum input voltage that, if exceeded at either input, could cause the device to malfunction.

Due to the extremely high input impedance and resulting low bias-current requirements, the TL03x and TL03xA are well suited for low-level signal processing; however, leakage currents on printed circuit boards and sockets easily can exceed bias-current requirements and cause degradation in system performance. It is a good practice to include guard rings around inputs (see Figure 61). These guard rings should be driven from a low-impedance source at the same voltage level as the common-mode input.

Unused amplifiers should be connected as grounded unity-gain followers to avoid oscillation.

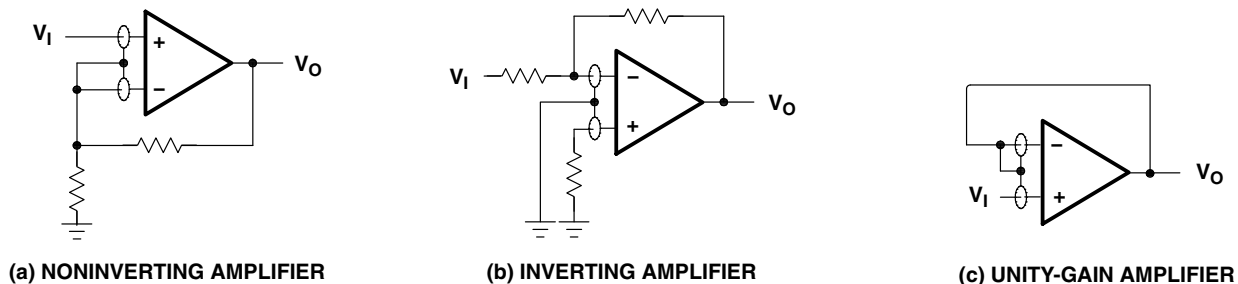


Figure 61. Use of Guard Rings

TL03x, TL03xA ENHANCED-JFET LOW-POWER LOW-OFFSET OPERATIONAL AMPLIFIERS

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APPLICATION INFORMATION

output characteristics

All operating characteristics (except bandwidth and phase margin) are specified with 100-pF load capacitance. The TL03x and TL03xA drive higher capacitive loads; however, as the load capacitance increases, the resulting response pole occurs at lower frequencies, thereby causing ringing, peaking, or even oscillation. The value of the load capacitance at which oscillation occurs varies with production lots. If an application appears to be sensitive to oscillation due to load capacitance, adding a small resistance in series with the load should alleviate the problem (see Figure 63). Capacitive loads of 1000 pF and larger can be driven if enough resistance is added in series with the output (see Figure 62).

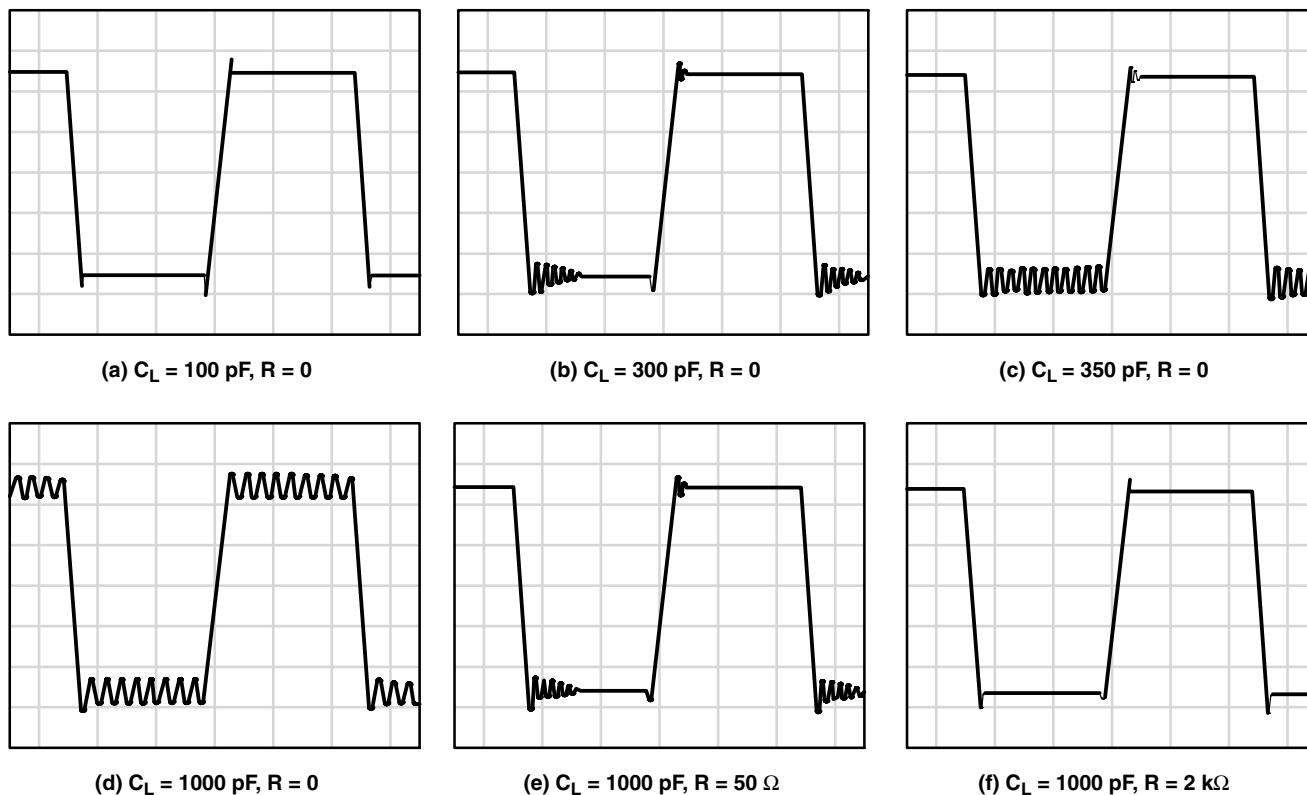


Figure 62. Effect of Capacitive Loads

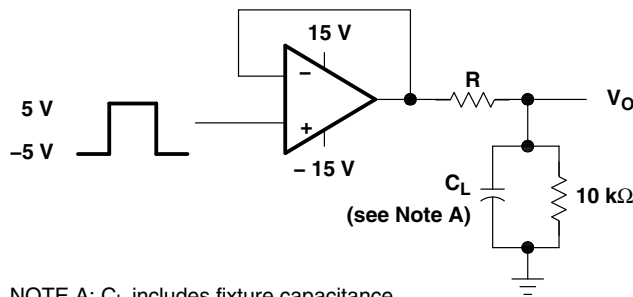


Figure 63. Test Circuit for Output Characteristics

APPLICATION INFORMATION

high-Q notch filter

In general, Texas Instruments enhanced-JFET operational amplifiers serve as excellent filters. The circuit in Figure 64 provides a narrow notch at a specific frequency. Notch filters are designed to eliminate frequencies that are interfering with the operation of an application. For this filter, the center frequency can be calculated as:

$$f_0 = \frac{1}{2\pi \times R1 \times C1}$$

With the resistors and capacitors shown in Figure 64, the center frequency is 1 kHz. $C1 = C3 = C2 + 2$ and $R1 = R3 = 2 \times R2$. The center frequency can be modified by varying these values. When adjusting the center frequency, ensure that the operational amplifier has sufficient gain at the frequency required.

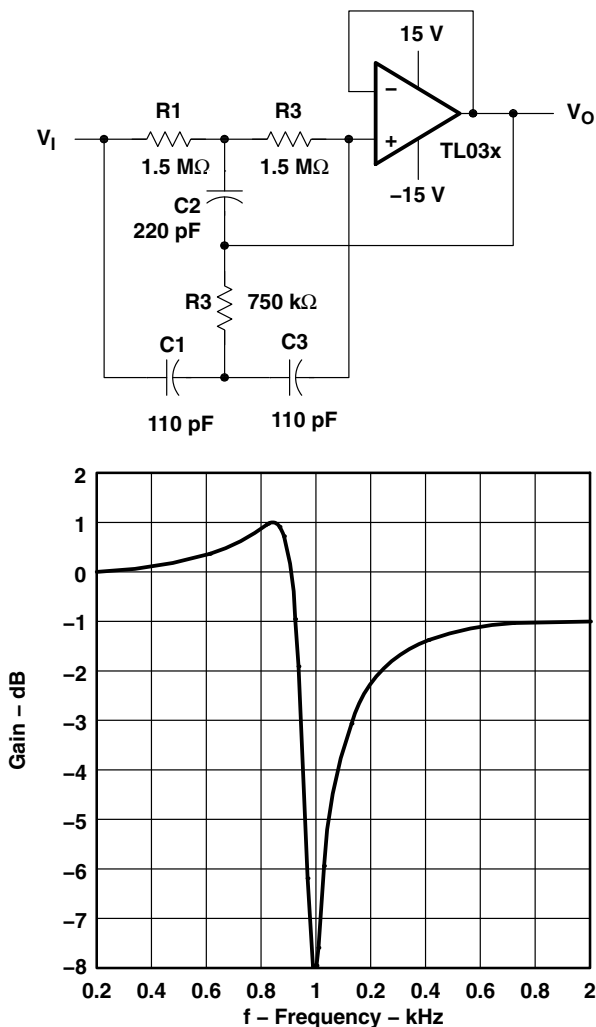


Figure 64. High-Q Notch Filter

TL03x, TL03xA ENHANCED-JFET LOW-POWER LOW-OFFSET OPERATIONAL AMPLIFIERS

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APPLICATION INFORMATION

transimpedance amplifier

The low-power precision TL03x allows accurate measurement of low currents. The high input impedance and low offset voltage of the TL03xA greatly simplify the design of a transimpedance amplifier. At room temperature, this design achieves 10-bit accuracy with an error of less than 1/2 LSB.

Assuming that R2 is much less than R1 and ignoring error terms, the output voltage can be expressed as:

$$V_O = -I_{IN} \times R_F \left(\frac{R_1 + R_2}{R_2} \right)$$

Using the resistor values shown in the schematic for a 1-nA input current, the output voltage equals -0.1 V. If the V_O limit for the TL03xA is measured at ± 12 V, the maximum input current for these resistor values is ± 120 nA. Similarly, one LSB on a 10-bit scale corresponds to 12 mV of output voltage, or 120 pA of input current.

The following equation shows the effect of input offset voltage and input bias current on the output voltage:

$$V_O = - \left[V_{IO} + R_F (I_{IO} + I_{IB}) \right] \left(\frac{R_1 + R_2}{R_2} \right)$$

If the application requires input protection for the transimpedance amplifier, do not use standard PN diodes. Instead, use low-leakage Siliconix SN4117 JFETs (or equivalent) connected as diodes across the TL03xA inputs (see Figure 65).

As with all precision applications, special care must be taken to eliminate external sources of leakage and interference. Other precautions include using high-quality insulation, cleaning insulating surfaces to remove fluxes and other residue, and enclosing the application within a protective box.

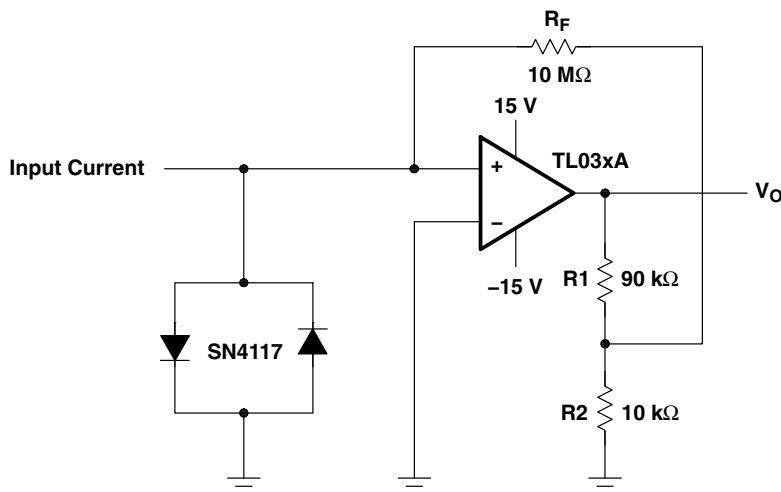


Figure 65. Transimpedance Amplifier

APPLICATION INFORMATION

4-mA to 20-mA current loops

Often, information from an analog sensor must be sent over a distance to the receiving circuitry. For many applications, the most feasible method involves converting voltage information to a current before transmission. The following circuits give two variations of low-power current loops. The circuit in Figure 66 requires three wires from the transmitting to receiving circuitry, while the second variation in Figure 67 requires only two wires, but includes an extra integrated circuit. Both circuits benefit from the high input impedance of the TL03xA because many inexpensive sensors do not have low output impedance.

Assuming that the voltage at the noninverting input of the TL03xA is zero, the following equation determines the output current:

$$I_O = V_I \left(\frac{R_3}{R_1 \times R_S} \right) + 5V \left(\frac{R_3}{R_2 \times R_S} \right) = 0.16 \times V_I + 4\text{mA}$$

The circuits presently provide 4-mA to 20-mA output current for an input voltage of 0 to 100 mV. By modifying R1, R2, and R3, the input voltage range or the output current range can be adjusted.

Including the offset voltage of the operational amplifier in the above equation clearly illustrates why the low offset TL03xA was chosen:

$$\begin{aligned} I_O &= V_I \left(\frac{R_3}{R_1 \times R_S} \right) + 5V \left(\frac{R_3}{R_2 \times R_S} \right) - V_I \left(\frac{R_3}{R_1 \times R_S} + \frac{R_3}{R_2 \times R_S} + \frac{R_1}{R_S} \right) \\ &= 0.16 \times V_I + 4\text{mA} - 0.17 \times V_I \end{aligned}$$

For example, an offset voltage of 1 mV decreases the output current by 0.17 mA.

Due to the low power consumption of the TL03xA, both circuits have at least 2 mA available to drive the actual sensor from the 5-V reference node.

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APPLICATION INFORMATION

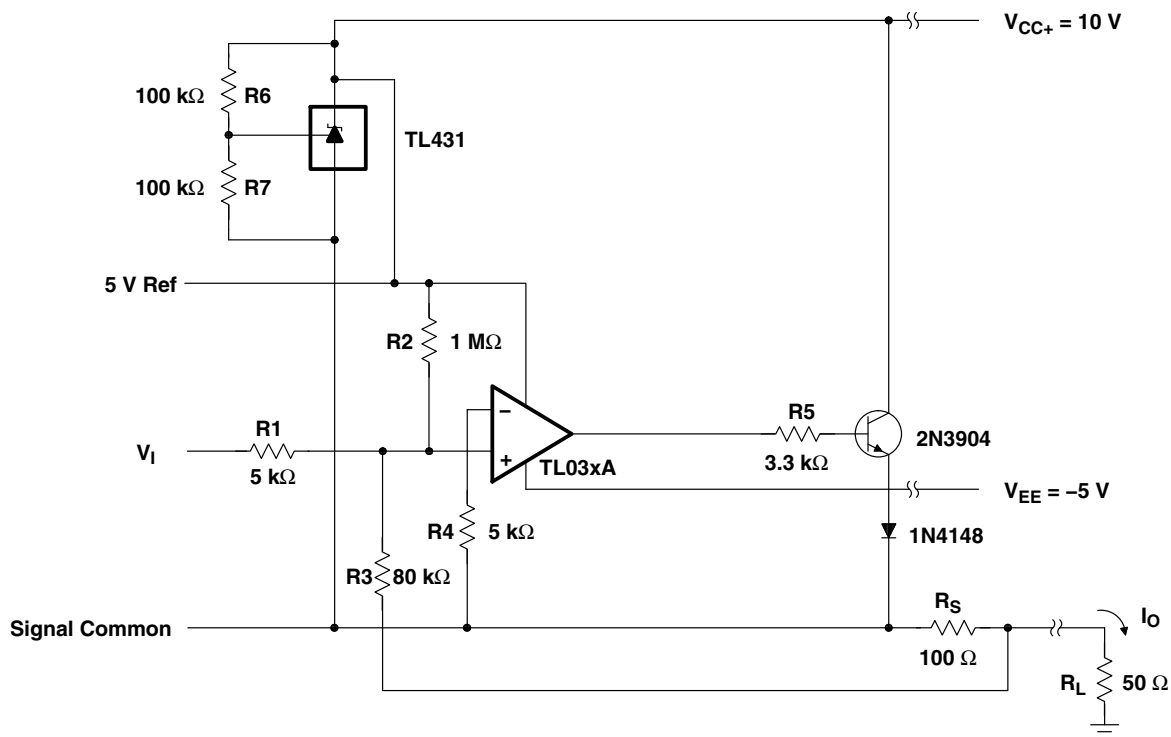


Figure 66. Three-Wire 4-mA to 20-mA Current Loop

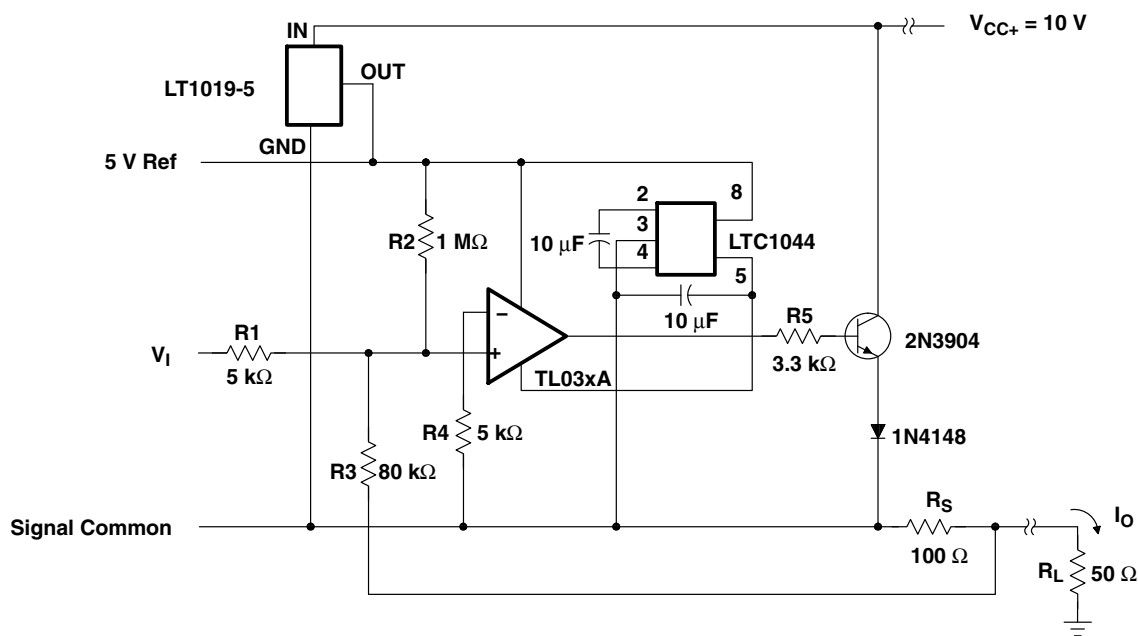


Figure 67. Two-Wire 4-mA to 20-mA Current Loop

APPLICATION INFORMATION

low-level light-detector preamplifier

Applications that need to detect small currents require high input-impedance operational amplifiers; otherwise, the bias currents of the operational amplifier camouflage the current being monitored. Phototransistors provide a current that is proportional to the light reaching the transistor. The TL03x allows even the small currents resulting from low-level light to be detected.

In Figure 68, if there is no light, the phototransistor is off and the output is high. As light is detected, the operational amplifier output begins pulling low. Adjusting R4 both compensates for offset voltage of the amplifier and adjusts the point of light detection by the amplifier.

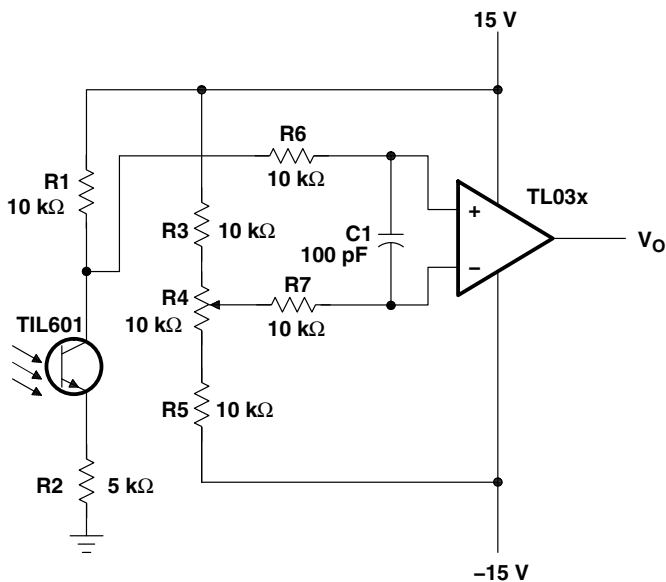


Figure 68. Low-Level Light-Detector Preamplifier

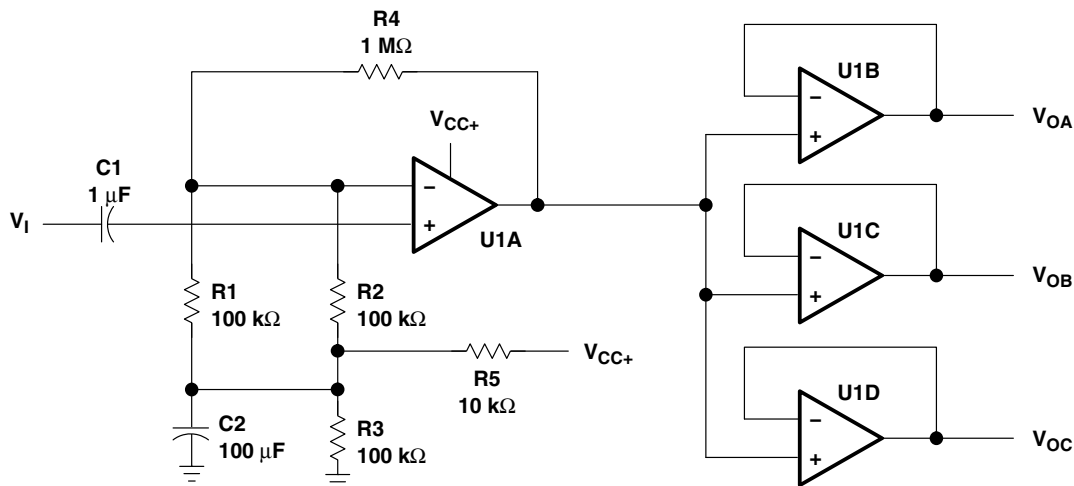
TL03x, TL03xA ENHANCED-JFET LOW-POWER LOW-OFFSET OPERATIONAL AMPLIFIERS

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APPLICATION INFORMATION

audio-distribution amplifier

This audio-distribution amplifier (see Figure 69) feeds the input signal to three separate output channels. U1A amplifies the input signal with a gain of 10, while U1B, U1C, and U1D serve as buffers to the output channels. The gain response of this circuit is very flat from 20 Hz to 20 kHz. The TL03x allows quick response to the input signal while maintaining low power consumption.



NOTE A: U1A through U1D = TL03x; $V_{CC+} = 5\text{ V}$

Figure 69. Audio-Distribution Amplifier Circuit

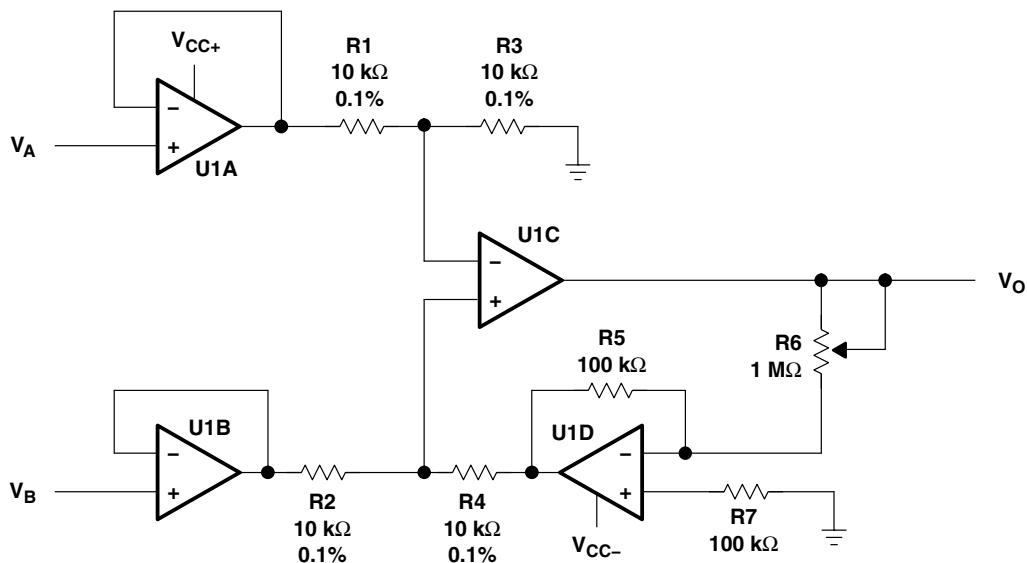
APPLICATION INFORMATION

instrumentation amplifier with linear gain adjust

The low offset voltage and low power consumption of the TL03x provide an accurate but inexpensive instrumentation amplifier (see Figure 70). This particular configuration offers the advantage that the gain can be linearly set by one resistor:

$$V_O = \frac{R_6}{R_5} \times (V_B - V_A)$$

Adjusting R6 varies the gain. The value of R6 always should be greater than, or equal to, the value of R5 to ensure stability. The disadvantage of this instrumentation amplifier topology is the high degree of CMRR degradation resulting from mismatches between R1, R2, R3, and R4. For this reason, these four resistors should be 0.1%-tolerance resistors.



NOTE A: U1A through U1D = TL03x; $V_{CC\pm} = \pm 15$ V

Figure 70. Instrumentation Amplifier With Linear Gain-Adjust Circuit

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TL031CD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	TL031C	Samples
TL031CDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	TL031C	Samples
TL031CP	ACTIVE	PDIP	P	8	50	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type	0 to 70	TL031CP	Samples
TL031ID	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	TL031I	Samples
TL031IDG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	TL031I	Samples
TL031IP	ACTIVE	PDIP	P	8	50	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type	-40 to 85	TL031IP	Samples
TL032ACD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	032AC	Samples
TL032ACDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	032AC	Samples
TL032ACP	ACTIVE	PDIP	P	8	50	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type	0 to 70	TL032ACP	Samples
TL032AID	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	032AI	Samples
TL032AIDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	032AI	Samples
TL032AIP	ACTIVE	PDIP	P	8	50	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type	-40 to 85	TL032AIP	Samples
TL032CD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	TL032C	Samples
TL032CDE4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	TL032C	Samples
TL032CDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	TL032C	Samples
TL032CDRG4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	TL032C	Samples
TL032CP	ACTIVE	PDIP	P	8	50	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type	0 to 70	TL032CP	Samples

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TL032CPE4	ACTIVE	PDIP	P	8	50	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type	0 to 70	TL032CP	Samples
TL032CPSR	ACTIVE	SO	PS	8	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	T032	Samples
TL032ID	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	TL032I	Samples
TL032IDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	TL032I	Samples
TL032IDRG4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	TL032I	Samples
TL032IP	ACTIVE	PDIP	P	8	50	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type	-40 to 85	TL032IP	Samples
TL034ACD	ACTIVE	SOIC	D	14	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	TL034AC	Samples
TL034ACDR	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	TL034AC	Samples
TL034ACN	ACTIVE	PDIP	N	14	25	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type	0 to 70	TL034ACN	Samples
TL034AID	ACTIVE	SOIC	D	14	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	TL034AI	Samples
TL034AIDR	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	TL034AI	Samples
TL034AIN	ACTIVE	PDIP	N	14	25	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type	-40 to 85	TL034AIN	Samples
TL034CD	ACTIVE	SOIC	D	14	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	TL034C	Samples
TL034CDR	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	TL034C	Samples
TL034CN	ACTIVE	PDIP	N	14	25	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type	0 to 70	TL034CN	Samples
TL034CNE4	ACTIVE	PDIP	N	14	25	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type	0 to 70	TL034CN	Samples
TL034CNSR	ACTIVE	SO	NS	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	TL034	Samples
TL034CPW	ACTIVE	TSSOP	PW	14	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	T034	Samples

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TL034CPWR	ACTIVE	TSSOP	PW	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	T034	Samples
TL034ID	ACTIVE	SOIC	D	14	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	TL034I	Samples
TL034IDR	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	TL034I	Samples
TL034IDRG4	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	TL034I	Samples
TL034IN	ACTIVE	PDIP	N	14	25	Green (RoHS & no Sb/Br)	CU NIPDAU	N / A for Pkg Type	-40 to 85	TL034IN	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSELETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "-" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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TAPE AND REEL INFORMATION

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TL031CDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TL032ACDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TL032AIDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TL032CDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TL032CPSR	SO	PS	8	2000	330.0	16.4	8.2	6.6	2.5	12.0	16.0	Q1
TL032IDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TL034AIDR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
TL034CDR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
TL034CNSR	SO	NS	14	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
TL034CPWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TL031CDR	SOIC	D	8	2500	340.5	338.1	20.6
TL032ACDR	SOIC	D	8	2500	340.5	338.1	20.6
TL032AIDR	SOIC	D	8	2500	340.5	338.1	20.6
TL032CDR	SOIC	D	8	2500	340.5	338.1	20.6
TL032CPSR	SO	PS	8	2000	367.0	367.0	38.0
TL032IDR	SOIC	D	8	2500	340.5	338.1	20.6
TL034AIDR	SOIC	D	14	2500	367.0	367.0	38.0
TL034CDR	SOIC	D	14	2500	367.0	367.0	38.0
TL034CNSR	SO	NS	14	2000	367.0	367.0	38.0
TL034CPWR	TSSOP	PW	14	2000	367.0	367.0	35.0

MECHANICAL DATA

NS (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

14-PINS SHOWN



- NOTES:
- All linear dimensions are in millimeters.
 - This drawing is subject to change without notice.
 - Body dimensions do not include mold flash or protrusion, not to exceed 0,15.

D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 -  Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
 -  Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
 - E. Reference JEDEC MS-012 variation AB.

D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Publication IPC-7351 is recommended for alternate designs.
 - D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
 - E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



4040064-3/G 02/11

- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 - B. This drawing is subject to change without notice.
 - C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
 - D. Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
 - E. Falls within JEDEC MO-153

PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



4211284-2/G 08/15

- NOTES:
- All linear dimensions are in millimeters.
 - This drawing is subject to change without notice.
 - Publication IPC-7351 is recommended for alternate designs.
 - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
 - Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

D (R-PDSO-G8)

PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
 - Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
 - E. Reference JEDEC MS-012 variation AA.

D (R-PDSO-G8)

PLASTIC SMALL OUTLINE



- NOTES:
- All linear dimensions are in millimeters.
 - This drawing is subject to change without notice.
 - Publication IPC-7351 is recommended for alternate designs.
 - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
 - Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

MECHANICAL DATA

PS (R-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.

PS (R-PDSO-G8)

PLASTIC SMALL OUTLINE



4212188/A 09/11

- NOTES:
- All linear dimensions are in millimeters.
 - This drawing is subject to change without notice.
 - Publication IPC-7351 is recommended for alternate designs.
 - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
 - Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

P (R-PDIP-T8)

PLASTIC DUAL-IN-LINE PACKAGE



4040082/E 04/2010

- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. Falls within JEDEC MS-001 variation BA.

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
 - D The 20 pin end lead shoulder width is a vendor option, either half or full width.

4040049/E 12/2002

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